

# EMC TEST REPORT

Dates of Tests: November 08 – 14, 2017  
Test Report S/N: LR500121711K  
Test Site : LTA Co., Ltd.

Model No.

**HE-1101**

APPLICANT

**IDIS CO., LTD.**

**Manufacturing Description** : **Video Encoder**  
**Manufacturer** : **IDIS CO., LTD.**  
**Model name** : **HE-1101**  
**Additional model name** : **-**  
**Test Device Serial No.:** : **Identification**  
**Directive** : **Electromagnetic Compatibility Directive 2014/30/EU**  
**Rule Part(s)** : **EN 55032:2015**  
**EN 50130-4:2011/A1:2014**  
**EN 61000-3-2:2014**  
**EN 61000-3-3:2013**  
**Data of reissue** : **November 16, 2017**

This test report is issued under the authority of:

The test was supervised by:



Young Kyu Shin, Technical Manager



Tae Won Kim, Test Engineer

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NVLAP LAB CODE 200723-0

Revision	Date of issue	Test report No.	Description
0	16.11.2017	LR500121711K	Initial

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## 1. General information's

### 1-1 Test Performed

Company name : **LTA Co., Ltd.**  
 Address : 243, Jubug-ri, Yangji-Myeon, Yongin-Si, Kyunggi-Do, Korea. 449-822  
 Web site : <http://www.ltalab.com>  
 E-mail : [chahn@ltalab.com](mailto:chahn@ltalab.com)  
 Telephone : +82-31-323-6008  
 Facsimile : +82-31-323-6010

Quality control in the testing laboratory is implemented as per ISO/IEC 17025 which is the “General requirements for the competents of calibration and testing laboratory”.

### 1-2 Accredited agencies

LTA Co., Ltd. is approved to perform EMC testing by the following agencies:

Agency	Country	Accreditation No.	Validity	Reference
NVLAP	U.S.A	200723-0	Updating	ECT accredited Lab.
RRA	KOREA	KR0049	-	EMC accredited Lab.
FCC	U.S.A	649054	2019-04-13	FCC CAB
VCCI	JAPAN	C-4948, T-2416, R-4483(10 m), G-847	2020-09-10 2020-09-10 2020-10-15 2018-12-13	VCCI registration
IC	CANADA	5799A-1	2019-11-07	IC filing
KOLAS	KOREA	NO.551	2021-08-20	KOLAS accredited Lab.

## 2. Information's about test item

### 2-1 Client/ Manufacturer

Company name : IDIS CO., LTD.  
 Address : 8-10, TECHNO 3-RO, YUSEONG-GU, DAEJEON, KOREA  
 Telephone / Facsimile : +82-31-723-5205 / +82-31-723-5108

### Factory

Company name : IDIS CO., LTD.  
 Address : 8-10, TECHNO 3-RO, YUSEONG-GU, DAEJEON, KOREA

### 2-2 Equipment Under Test (EUT)

Class : A  
 Category : Video Encoder  
 Model name : HE-1101  
 Additional Model Name : -  
 Serial number : Identification  
 Date of receipt : October 24, 2017  
 EUT condition : Pre-production, not damaged  
 Interface ports : DC IN, HDMI IN, HDMI OUT, D-Sub IN, D-Sub OUT, Audio IN, Audio OUT,  
 : LAN, USB-B  
 Power rating : DC 12 V (Used for Adapter)  
 Modulator : -  
 Crystal/Oscillator(s) : -  
 Firmware version : XXXX

### 2-3 Modification

-NONE

### 2-4 Model Specification

-NONE

### 2-5 Test conditions

Temp. / Humid. / Pressure : +(18 - 23) °C / (34 - 47) %RH / (99.9) kPa  
 Tested Model : HE-1101  
 Test mode : 1 kHz + Operating mode (Adapter, PoE)  
 Power supply : AC 230 V / 50 Hz

**2-6 Ancillary Equipment / 1 kHz + Operating mode (Adapter)**

Equipment	Model No.	Serial No.	Manufacturer
Adapter	JP6004AS	SB1604000099	SEUNG BO ELECOM
NVR	N/A	N/A	N/A
Monitor #1	P2416D	N/A	DELL
Moniotr #2	U2412M	N/A	DELL
Mobile Phone	IM-A770K	N/A	SKY
Earphone	N/A	N/A	SAMSUNG

**2-6 Ancillary Equipment / 1 kHz + Operating mode (PoE)**

Equipment	Model No.	Serial No.	Manufacturer
PoE Adapter	PSE305	N/A	Gigabit
NVR	N/A	N/A	N/A
Monitor #1	P2416D	N/A	DELL
Moniotr #2	U2412M	N/A	DELL
Mobile Phone	IM-A770K	N/A	SKY
Earphone	N/A	N/A	SAMSUNG

### 3. Test Report

#### 3.1 Summary of tests

Parameter	Applied Standard	Status
<b>I. Emission</b>		
Radiated Emission	EN 55032:2015	C
Conducted Emission	EN 55032:2015	C
Harmonic Current Emission	EN 61000-3-2:2014	C
Voltage Fluctuations and Flicker	EN 61000-3-3:2013	C
<b>II. Immunity</b>		
Electrostatic Discharge	EN 61000-4-2:2009	C
RF Electromagnetic field	EN 61000-4-3:2006/A2:2010	C
Fast Transients Common mode	EN 61000-4-4:2012	C
Surges, line to line and line to ground	EN 61000-4-5:2014	C
RF common mode	EN 61000-4-6:2014	C
Voltage dips and Interruptions	EN 61000-4-11:2004	C
Main supply voltage variations	EN 50130-4:2011	C

Note 1: C=Complies    NC=Not Complies    NT=Not Tested    NA=Not Applicable

Note 2: The device is operated by DC Power.

Note 3: The data in this test report are traceable to the national or international standards.

## 3.2 EMISSION

### 3.2.1 Conducted emissions

#### Definition:

The test assesses the ability of the EUT to limit its internal noise from being present on the AC mains Power In/Output ports.

We were performed the test according to LTA procedure LTA-QI-04.

Measurement Frequency range	: 150 kHz - 30MHz
Test method	: EN 55032:2015
Measurement RBW	: 9 kHz
Test mode	: 1 kHz + Operating mode (Adapter, PoE)
Result	: <b>Complies</b>

#### Measurement Data:

- Refer to the Next page (Maximum emission configuration)

#### A sample calculation:

COR. F (correction factor)= LISN Insertion loss + Cable loss

Emission Level= meter reading + COR.F

#### Limits for conducted disturbance at the mains ports of class A ITE

Frequency Range	Quasi-peak	Average
(0.15 – 0.5) MHz	79 dBuV	66 dBuV
(0.5 – 30) MHz	73 dBuV	60 dBuV

Note: The limits will decrease with the frequency logarithmically within 0.15MHz to 0.5MHz

#### Limits for conducted disturbance at the mains ports of class B ITE

Frequency Range	Quasi-peak	Average
(0.15 – 0.5) MHz	(66 – 56) dBuV	(56 - 46) dBuV
(0.5 – 5) MHz	56 dBuV	46 dBuV
(5 – 30) MHz	60 dBuV	50 dBuV

Note: The limits will decrease with the frequency logarithmically within 0.15 MHz to 0.5 MHz



**Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15 MHz to 30 MHz for class A equipment**

Frequency Range	Voltage limits		Current limits	
	Quasi-peak	Average	Quasi-peak	Average
(0.15 – 0.5) MHz	(97 – 87) dBuV	(84 – 74) dBuV	(53 – 43) dBuV	(40 – 30) dBuV
(0.5 – 30) MHz	87 dBuV	74 dBuV	43 dBuV	30 dBuV

Note 1: The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

Note 2: The current and voltage disturbance limits are derived for use with an impedance stabilization network (ISN) which presents a common mode (asymmetric mode) impedance of  $150\Omega$  to the telecommunication port under test (conversion factor is  $20 \log_{10} 150/I = 44$  dB)

**Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15 MHz to 30 MHz for class B equipment**

Frequency Range	Voltage limits		Current limits	
	Quasi-peak	Average	Quasi-peak	Average
(0.15 – 0.5) MHz	(84 – 74) dBuV	(74 – 64) dBuV	(40 – 30) dBuV	(30 – 20) dBuV
(0.5 – 30) MHz	74 dBuV	64 dBuV	30 dBuV	20 dBuV

Note 1: The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

Note 2: The current and voltage disturbance limits are derived for use with an impedance stabilization network (ISN) which presents a common mode (asymmetric mode) impedance of  $150\Omega$  to the telecommunication port under test (conversion factor is  $20 \log_{10} 150/I = 44$  dB)

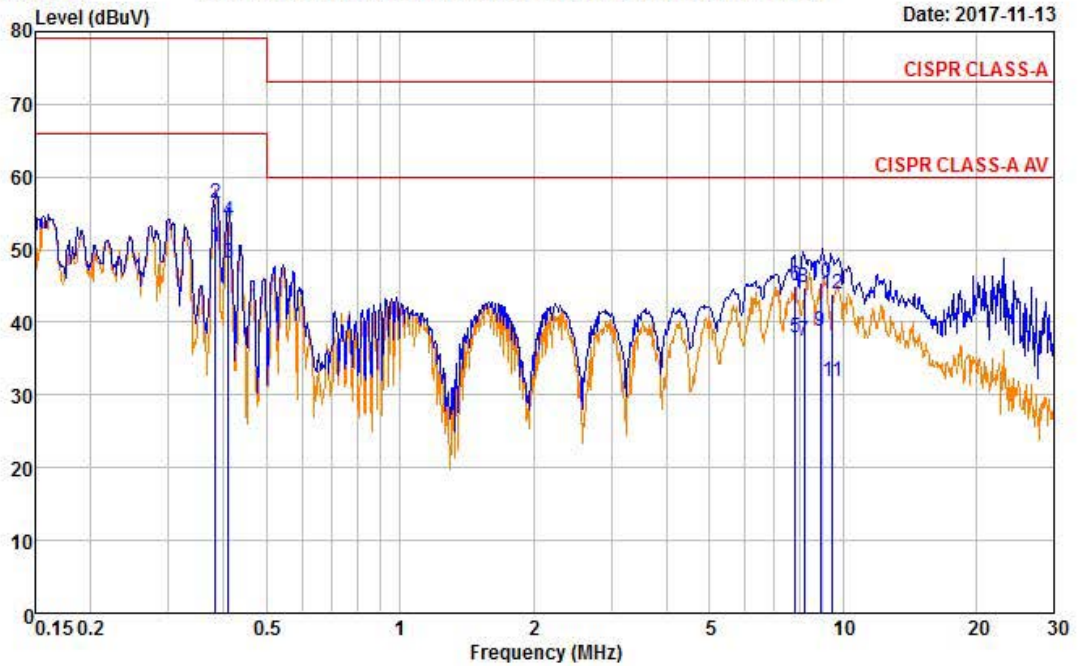
Conducted emissions / LINE \_ 1 kHz + Operating mode (Adapter)



4, Songjuro 236 Beon-gil, Yangji-myeon  
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EUT / Model No. : HE-1101 Phase : LINE  
 Test Mode : 1kHz + Operating mode Test Power : 230 / 50  
 Temp. / Humi. : 20 / 41 Test Engineer : KIM T W

Data: 1271 File: D:\Conducted Data\2017\LTA\_Conduction\_2017\_11 .EM6 (1641)



Freq	RD	RD	C.F	Result	Result	Limit	Limit	Margin	Margin
MHz	QP	AV	dB	QP	AV	QP	AV	QP	AV
	dBuV	dBuV		dBuV	dBuV	dBuV	dBuV	dB	dB
0.383	36.98	30.89	19.44	56.42	50.33	79.00	66.00	22.58	15.67
0.409	34.51	28.63	19.44	53.95	48.07	79.00	66.00	25.05	17.93
7.802	25.57	18.38	19.53	45.10	37.91	73.00	60.00	27.90	22.09
8.179	25.26	18.00	19.53	44.79	37.53	73.00	60.00	28.21	22.47
8.895	25.81	19.13	19.55	45.36	38.68	73.00	60.00	27.64	21.32
9.467	24.33	12.33	19.56	43.89	31.89	73.00	60.00	29.11	28.11

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

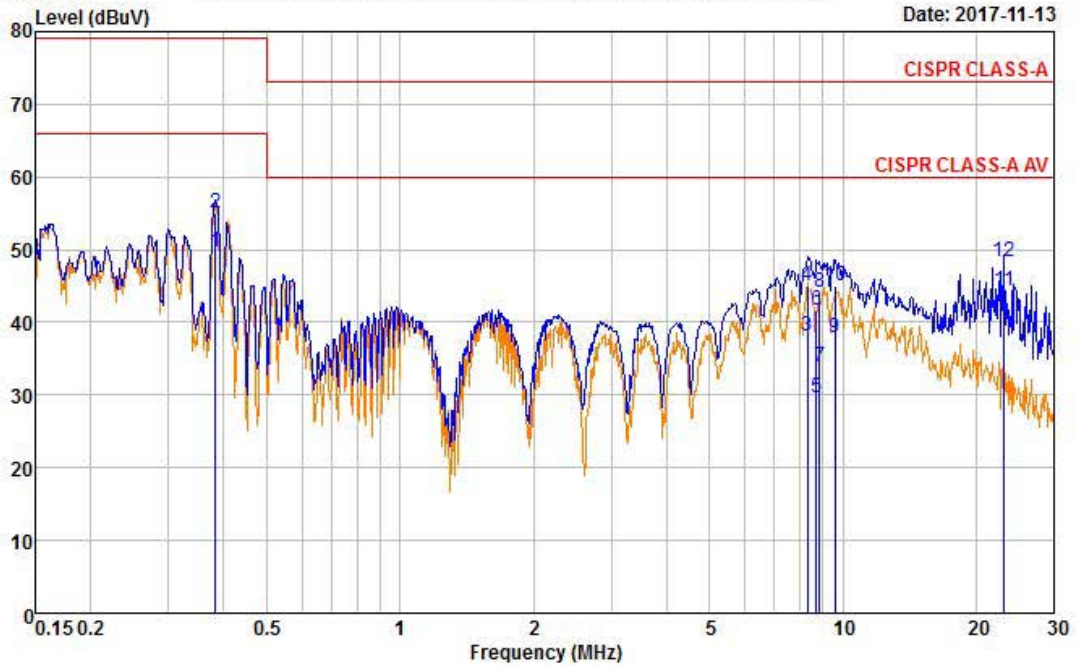
Conducted emissions / NEUTRAL \_ 1 kHz + Operating mode (Adapter)



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EUT / Model No. : HE-1101 Phase : NEUTRAL  
 Test Mode : 1kHz + Operating mode Test Power : 230 / 50  
 Temp. / Humi. : 20 / 41 Test Engineer : KIM T W

Data: 1267 File: D:\Conducted Data\2017\LTA\_Conduction\_2017\_11 .EM6 (1641)



Freq	RD	RD	C.F	Result	Result	Limit	Limit	Margin	Margin
MHz	QP	AV	dB	QP	AV	QP	AV	QP	AV
	dBuV	dBuV		dBuV	dBuV	dBuV	dBuV	dB	dB
0.383	35.58	30.26	19.42	55.00	49.68	79.00	66.00	24.00	16.32
8.311	25.49	18.57	19.52	45.01	38.09	73.00	60.00	27.99	21.91
8.720	22.14	10.14	19.55	41.69	29.69	73.00	60.00	31.31	30.31
8.879	24.54	14.41	19.55	44.09	33.96	73.00	60.00	28.91	26.04
9.599	25.36	18.25	19.56	44.92	37.81	73.00	60.00	28.08	22.19
23.129	28.62	24.50	19.74	48.36	44.24	73.00	60.00	24.64	15.76

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

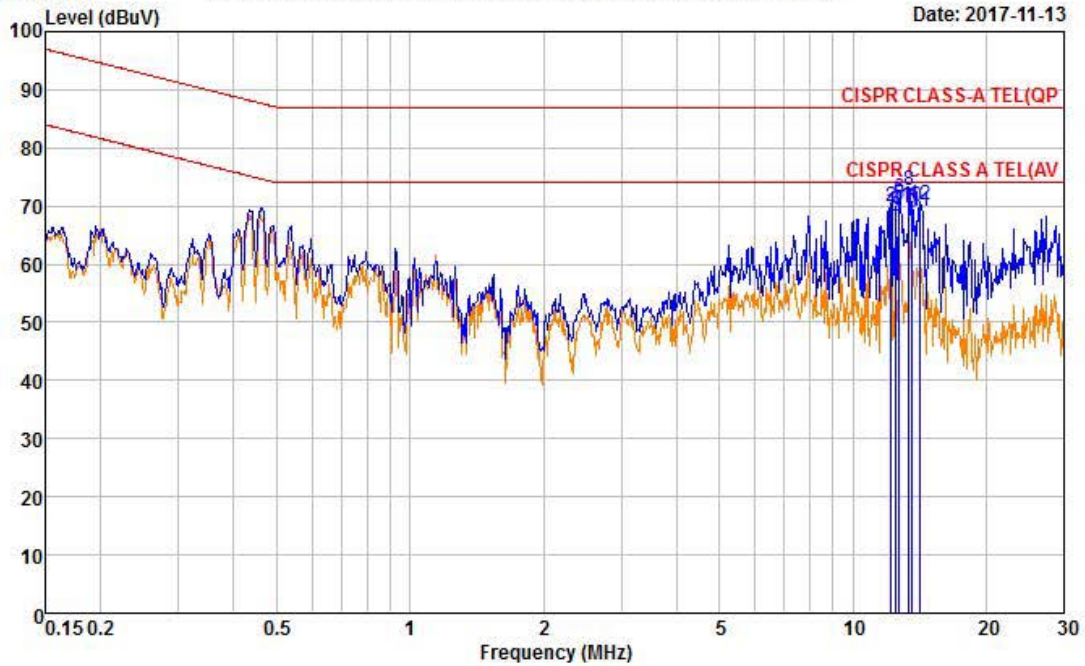
Conducted emissions / TEL\_10 M \_ 1 kHz + Operating mode (Adapter)



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EUT / Model No. : HE-1101 Phase : TEL\_10M  
Test Mode : 1kHz + Operating mode Test Power : 230 / 50  
Temp. / Humi. : 20 / 41 Test Engineer : KIM T W

Data: 1293 File: D:\Conducted Data\2017\LTA\_Conduction\_2017\_11 .EM6 (1641) Date: 2017-11-13



Freq	RD	RD	C.F	Result	Result	Limit	Limit	Margin	Margin
MHz	QP	AV	dB	QP	AV	QP	AV	QP	AV
	dBuV	dBuV		dBuV	dBuV	dBuV	dBuV	dB	dB
12.198	50.26	49.22	19.73	69.99	68.95	87.00	74.00	17.01	5.05
12.504	49.46	48.46	19.74	69.20	68.20	87.00	74.00	17.80	5.80
12.748	51.56	50.55	19.75	71.31	70.30	87.00	74.00	15.69	3.70
13.420	52.83	49.79	19.76	72.59	69.55	87.00	74.00	14.41	4.45
13.603	50.22	49.16	19.77	69.99	68.93	87.00	74.00	17.01	5.07
14.213	50.30	49.26	19.79	70.09	69.05	87.00	74.00	16.91	4.95

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter



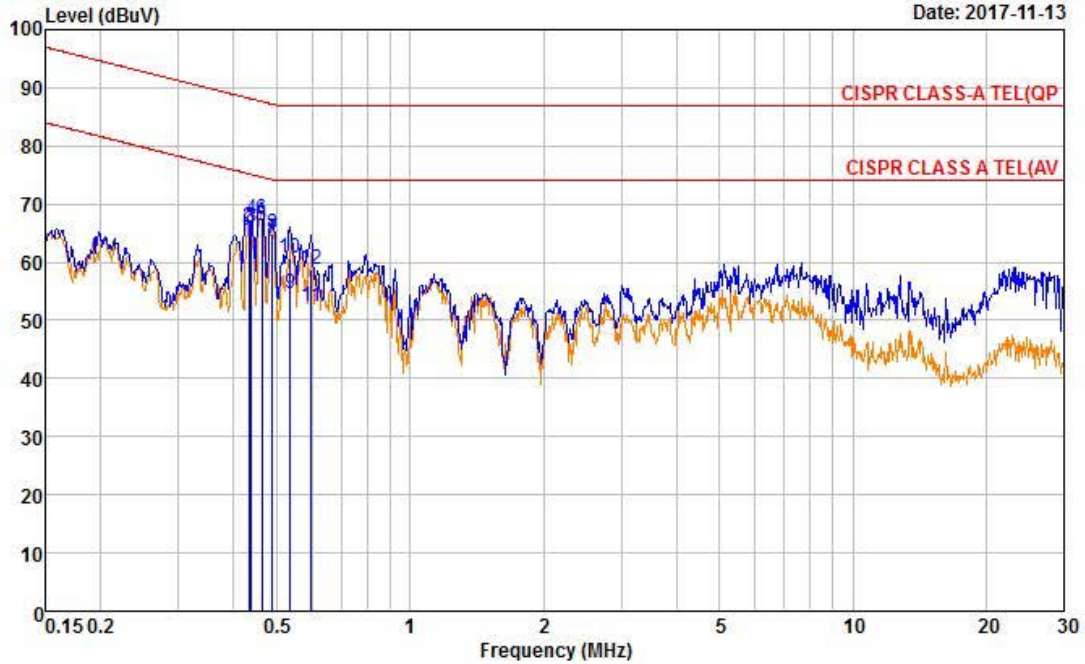
Conducted emissions / TEL\_100 M \_ 1 kHz + Operating mode (Adapter)



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EUT / Model No. : HE-1101 Phase : TEL\_100M  
Test Mode : 1kHz + Operating mode Test Power : 230 / 50  
Temp. / Humi. : 20 / 41 Test Engineer : KIM T W

Data: 1297 File: D:\Conducted Data\2017\LTA\_Conduction\_2017\_11 .EM6 (1641) Date: 2017-11-13



Freq	RD	RD	C.F	Result	Result	Limit	Limit	Margin	Margin
MHz	QP	AV	dB	QP	AV	QP	AV	QP	AV
	dBuV	dBuV		dBuV	dBuV	dBuV	dBuV	dB	dB
0.433	46.43	44.21	19.70	66.13	63.91	88.20	75.20	22.07	11.29
0.438	47.68	46.43	19.69	67.37	66.12	88.11	75.11	20.74	8.99
0.462	47.73	46.71	19.68	67.41	66.39	87.66	74.66	20.25	8.27
0.488	45.11	44.53	19.67	64.78	64.20	87.20	74.20	22.42	10.00
0.537	41.11	34.93	19.66	60.77	54.59	87.00	74.00	26.23	19.41
0.598	39.08	32.83	19.63	58.71	52.46	87.00	74.00	28.29	21.54

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

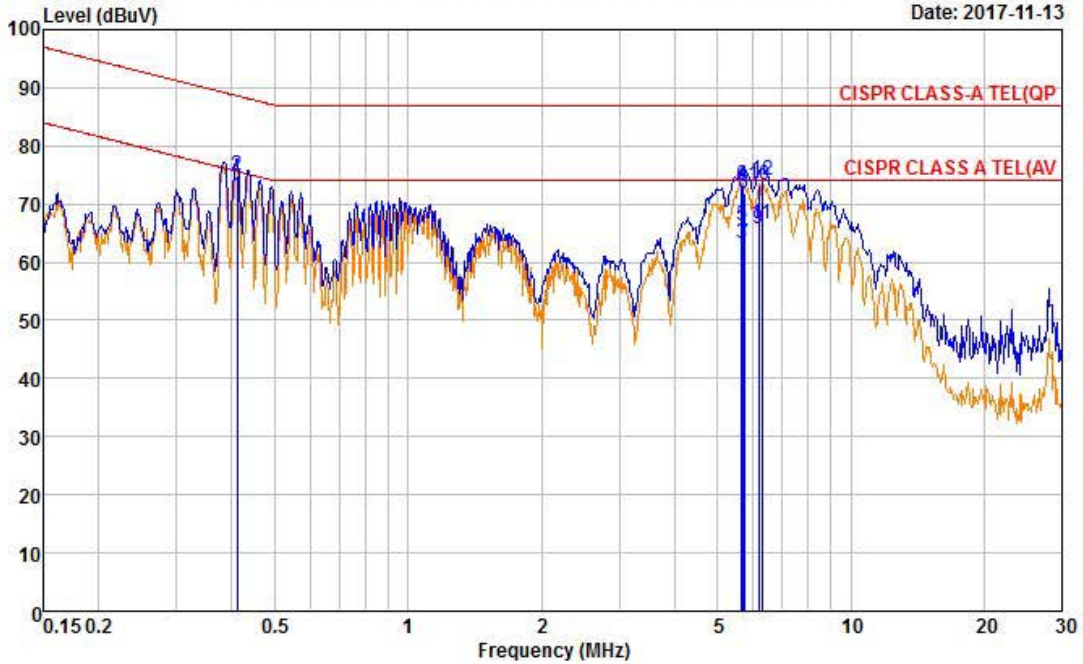
Conducted emissions / TEL\_10 M \_ 1 kHz + Operating mode (PoE)



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EUT / Model No. : HE-1101 Phase : TEL\_10M  
 Test Mode : 1kHz + Operating mode Test Power : 230 / 50  
 Temp. / Humi. : 20 / 41 Test Engineer : KIM T W

Data: 1255 File: D:\Conducted Data\2017\LTA\_Conduction\_2017\_11 .EM6 (1641) Date: 2017-11-13



Freq	RD	RD	C.F	Result	Result	Limit	Limit	Margin	Margin
MHz	QP	AV	dB	QP	AV	QP	AV	QP	AV
	dBuV	dBuV		dBuV	dBuV	dBuV	dBuV	dB	dB
0.411	55.21	51.52	19.72	74.93	71.24	88.63	75.63	13.70	4.39
5.676	53.84	43.68	19.54	73.38	63.22	87.00	74.00	13.62	10.78
5.694	53.84	46.65	19.54	73.38	66.19	87.00	74.00	13.62	7.81
5.755	52.28	43.78	19.54	71.82	63.32	87.00	74.00	15.18	10.68
6.190	53.82	46.22	19.55	73.37	65.77	87.00	74.00	13.63	8.23
6.293	54.41	47.01	19.56	73.97	66.57	87.00	74.00	13.03	7.43

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

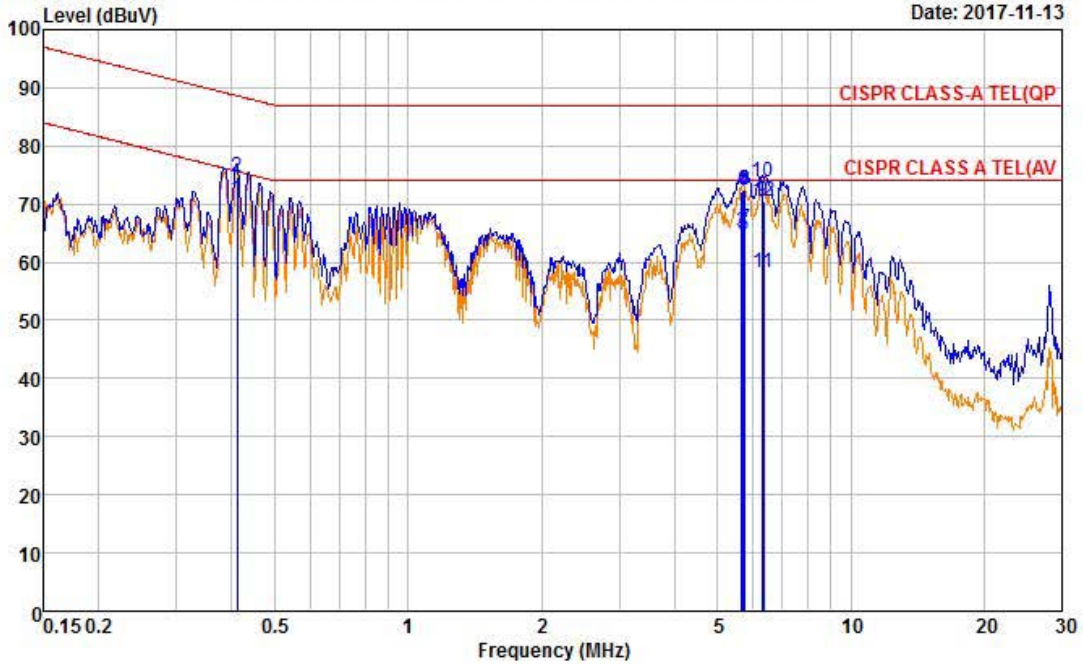
Conducted emissions / TEL\_100 M \_ 1 kHz + Operating mode (PoE)



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EUT / Model No. : HE-1101 Phase : TEL\_100M  
Test Mode : 1kHz + Operating mode Test Power : 230 / 50  
Temp. / Humi. : 20 / 41 Test Engineer : KIM T W

Data: 1251 File: D:\Conducted Data\2017\LTA\_Conduction\_2017\_11 .EM6 (1641) Date: 2017-11-13



Freq	RD	RD	C.F	Result	Result	Limit	Limit	Margin	Margin
MHz	QP	AV	dB	QP	AV	QP	AV	QP	AV
	dBuV	dBuV		dBuV	dBuV	dBuV	dBuV	dB	dB
0.410	55.05	51.09	19.71	74.76	70.80	88.64	75.64	13.88	4.84
5.682	52.64	45.59	19.53	72.17	65.12	87.00	74.00	14.83	8.88
5.711	52.87	45.00	19.53	72.40	64.53	87.00	74.00	14.60	9.47
5.766	52.86	46.09	19.53	72.39	65.62	87.00	74.00	14.61	8.38
6.340	54.13	50.96	19.55	73.68	70.51	87.00	74.00	13.32	3.49
6.351	50.87	38.77	19.55	70.42	58.32	87.00	74.00	16.58	15.68

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

### 3.2.2 Radiated Emission

**Definition:**

The test assesses the ability of ancillary equipment to limit their internal noise from being radiated from the enclosure.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	:	EN 55032:2015
Measuring Distance	:	10m
Measurement Frequency range	:	30 MHz – 6 000 MHz
Measurement RBW	:	120 kHz
Test mode	:	1 kHz + Operating mode (Adapter, PoE)
Result	:	<b>Complies</b>

**Measurement Data:**

- Refer to the Next page (Maximum emission configuration)

**A sample calculation:**

COR. F (correction factor)= Antenna factor + Cable loss- Amp.gain- Distance correction

Emission Level= meter reading + COR.F



Limit of 10 m for below 1 GHz

CLASS A

Frequency Range	Quasi-peak
(30 – 230) MHz	40 dBuV/m
(230 – 1 000) MHz	47 dBuV/m

CLASS B

Frequency Range	Quasi-peak
(30 – 230) MHz	30 dBuV/m
(230 – 1 000) MHz	37 dBuV/m

Limit of 3m for above 1 GHz

CLASS A

Frequency Range	Average Limit @ 3m (dB $\mu$ V/m)	Peak limit @ 3m (dB $\mu$ V/m)
(1 000 – 3 000) MHz	56	76
(3 000 – 6 000) MHz	60	80
NOTE:	The lower limit applies at the transition frequency.	

CLASS B

Frequency Range	Average Limit @ 3m (dB $\mu$ V/m)	Peak limit @ 3m (dB $\mu$ V/m)
(1 000 – 3 000) MHz	50	70
(3 000 – 6 000) MHz	54	74
NOTE:	The lower limit applies at the transition frequency.	

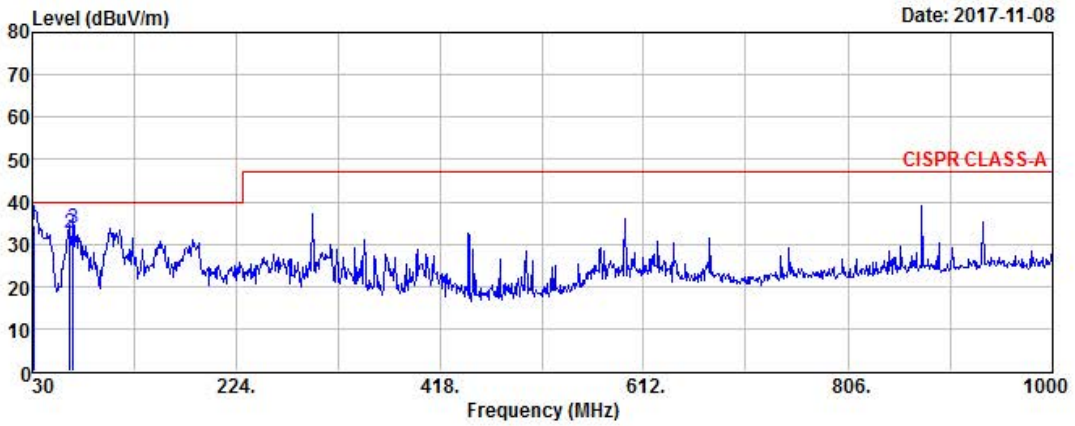
**Radiated Emission (Below 1 GHz) / V \_ 1 kHz + Operating mode (Adapter)**



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www.ltalab.com

EUT/Model No.: HE-1101 Temp/Humi: 21 / 47  
-----  
Test Mode : 1kHz + Operating mode Tested by: KIM T W  
-----

Data: 2097 File: C:\Program Files (x86)\e3\1709-1.EM6 (2109)



Freq MHz	Reading dBuV	C.F dB	Result QP dBuV/m	Limit dBuV/m	Margin dB	Height cm	Angle deg	Polarity
30.97	49.42	-15.13	34.29	40.00	5.71	101	231	VERTICAL
65.89	47.86	-15.32	32.54	40.00	7.46	114	164	VERTICAL
68.80	49.47	-15.64	33.83	40.00	6.17	105	204	VERTICAL

Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

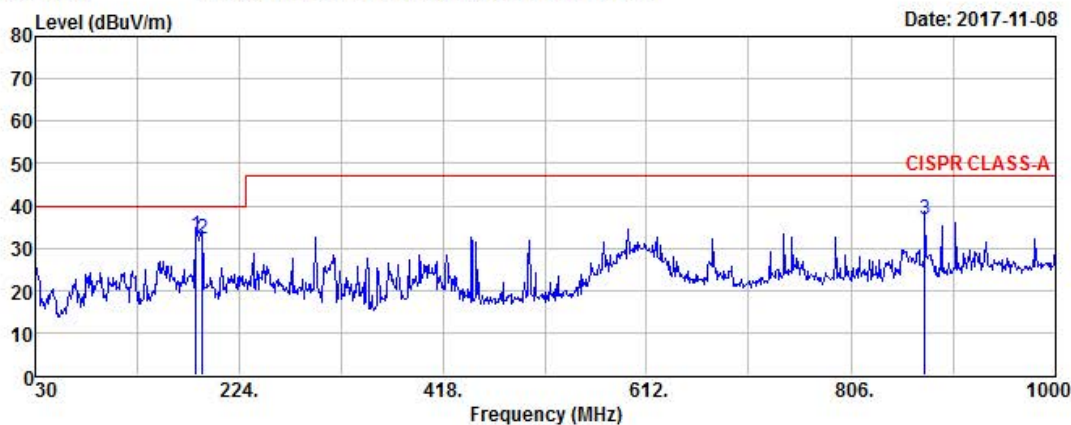
**Radiated Emission (Below 1 GHz) / H\_ 1 kHz + Operating mode (Adapter)**



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EUT/Model No.: HE-1101 Temp/Humi: 21 / 47  
 -----  
 Test Mode : 1kHz + Operating mode Tested by: KIM T W  
 -----

Data: 2096 File: C:\Program Files (x86)\e3\1709-1.EM6 (2109)



Freq MHz	Reading dBuV	C.F dB	Result QP dBuV/m	Limit dBuV/m	Margin dB	Height cm	Angle deg	Polarity
183.26	46.54	-13.68	32.86	40.00	7.14	387	148	HORIZONTAL
189.08	46.27	-14.25	32.02	40.00	7.98	396	177	HORIZONTAL
875.84	36.48	0.15	36.63	47.00	10.37	381	184	HORIZONTAL

Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

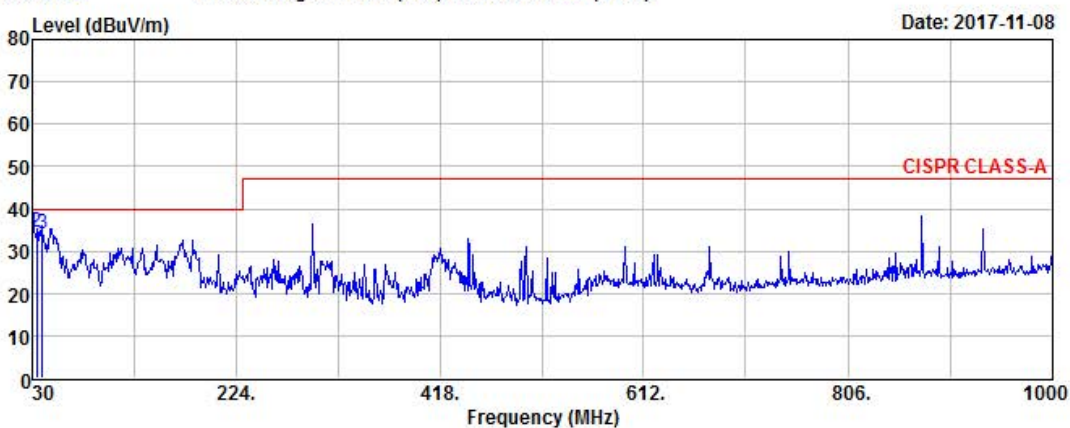
**Radiated Emission (Below 1 GHz) / V \_ 1 kHz + Operating mode (PoE)**



4, Songjuro 236Beon-gil, yanggi-myeon,  
Yongin-si, Gyeonggi-do, Korea  
Tel : +82-31-3236008,9  
Fax : +82-31-3236010  
www.ltalab.com

EUT/Model No.: HE-1101 (PoE) Temp/Humi: 21 / 47  
-----  
Test Mode : 1kHz + Operating mode Tested by: KIM T W  
-----

Data: 2101 File: C:\Program Files (x86)\e3\1709-1.EM6 (2109)



Freq MHz	Reading dBuV	C.F dB	Result QP dBuV/m	Limit dBuV/m	Margin dB	Height cm	Angle deg	Polarity
30.00	49.53	-15.23	34.30	40.00	5.70	100	152	VERTICAL
33.88	49.22	-14.84	34.38	40.00	5.62	105	164	VERTICAL
39.70	48.18	-14.26	33.92	40.00	6.08	114	211	VERTICAL

Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

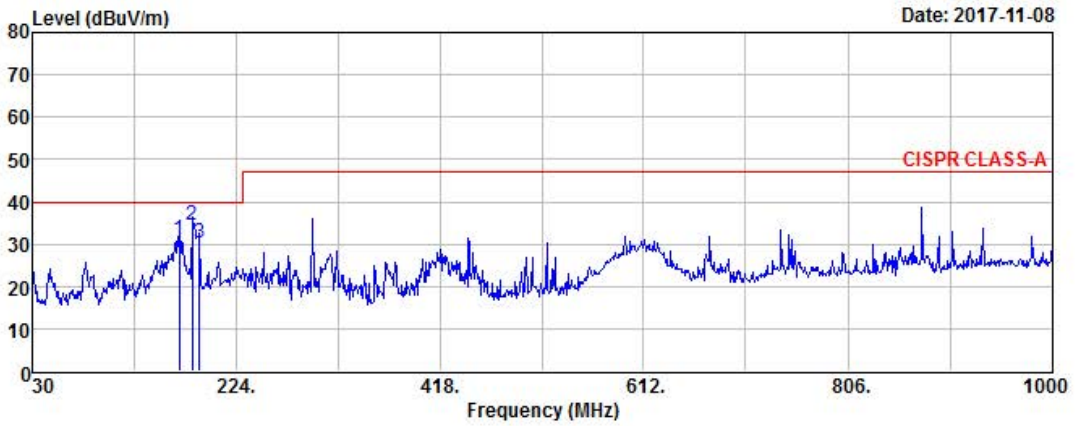
**Radiated Emission (Below 1 GHz) / H\_ 1 kHz + Operating mode (PoE)**



4, Songjuro 236Beon-gil, yanggi-myeon,  
Yongin-si, Gyeonggi-do, Korea  
Tel : +82-31-3236008,9  
Fax : +82-31-3236010  
www.ltalab.com

EUT/Model No.: HE-1101 (PoE) Temp/Humi: 21 / 47  
-----  
Test Mode : 1kHz + Operating mode Tested by: KIM T W  
-----

Data: 2100 File: C:\Program Files (x86)\e3\1709-1.EM6 (2109)



Freq MHz	Reading dBuV	C.F dB	Result QP dBuV/m	Limit dBuV/m	Margin dB	Height cm	Angle deg	Polarity
169.68	43.31	-12.33	30.98	40.00	9.02	388	194	HORIZONTAL
182.29	47.92	-13.58	34.34	40.00	5.66	391	184	HORIZONTAL
189.08	44.61	-14.25	30.36	40.00	9.64	392	166	HORIZONTAL

Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain



### Radiated Emission (Above 1 GHz) / 1 kHz + Operating mode (Adapter)

EUT/Model No.: HE-1101

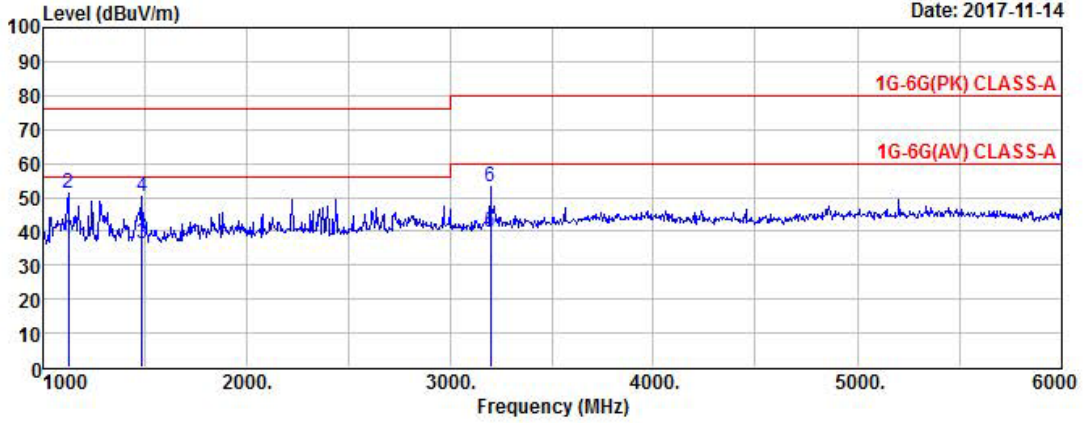
Temp/Humi: 18 / 34

Test Mode : 1kHz + Operating mode

Tested by: KIM T W

Data: 749 File: C:\Program Files (x86)\e3\1711-1.EM6 (1004)

Date: 2017-11-14



EUT/Model No.: HE-1101

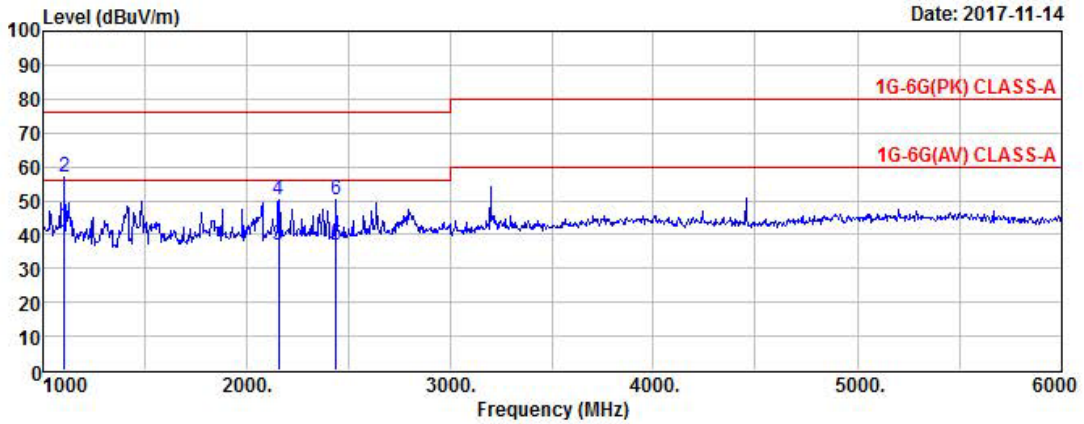
Temp/Humi: 18 / 34

Test Mode : 1kHz + Operating mode

Tested by: KIM T W

Data: 750 File: C:\Program Files (x86)\e3\1711-1.EM6 (811)

Date: 2017-11-14



Distance : 4.5 m

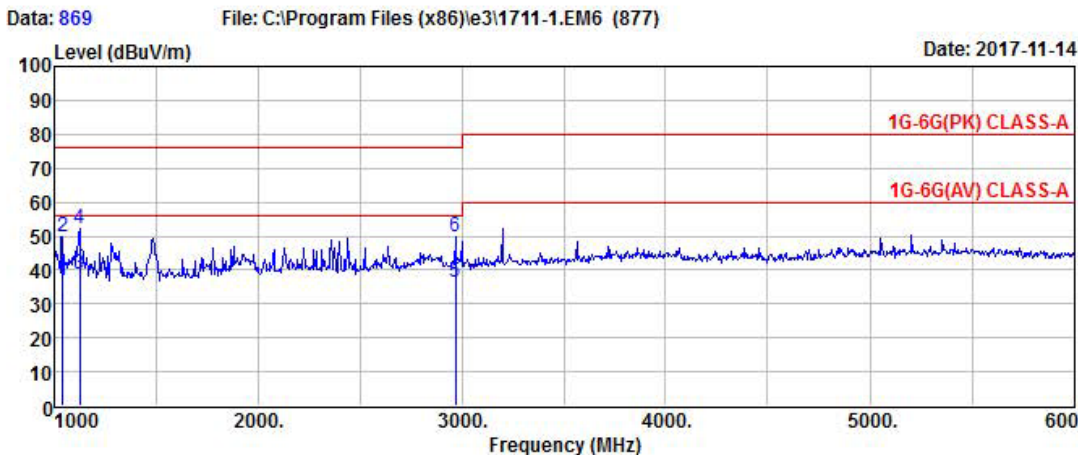
Ver Data: 749

Hor Data: 750

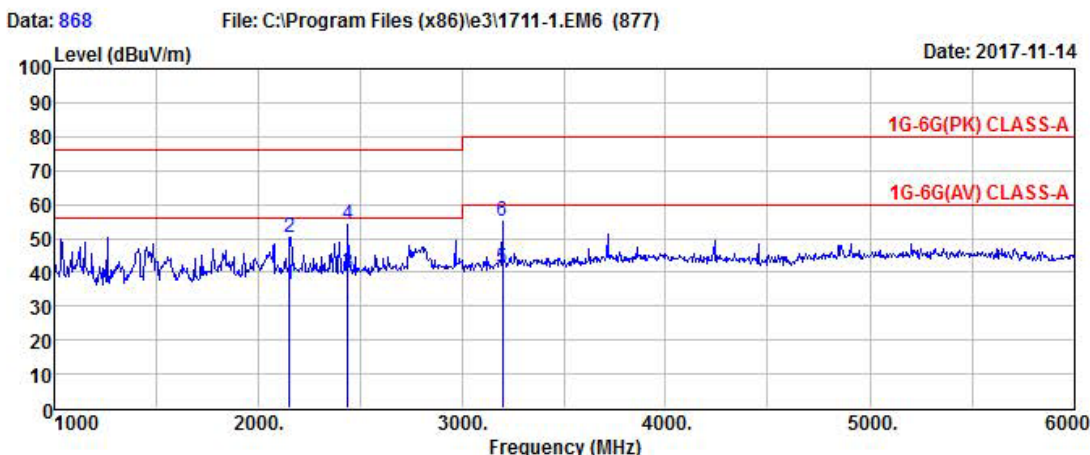
Freq.(MHz) MHz	Reading(PK) dBuV	Reading(AV) dBuV	C.F dB	Result(PK) dBuV/m	Result(AV) dBuV/m	Limit(PK) dBuV/m	Limit(AV) dBuV/m	Margin(PK) dB	Margin(AV) dB	Height cm	Angle deg	Polarity Hor/Ver
1105.0	67.0	52.5	-6.49	60.49	45.96	76.0	56.0	15.51	10.04	100	198	H
2160.0	53.4	40.0	0.2	53.62	40.15	76.0	56.0	22.38	15.85	100	201	H
2440.0	52.5	38.8	1.44	53.92	40.20	76.0	56.0	22.08	15.80	100	184	H
1125.0	61.0	47.7	-6.25	54.75	41.42	76.0	56.0	21.25	14.58	100	172	V
1485.0	58.2	44.8	-4.72	53.52	40.05	76.0	56.0	22.48	15.95	100	166	V
3200.0	50.6	37.3	6	56.61	43.33	80.0	60.0	23.39	16.67	100	194	V

### Radiated Emission (Above 1 GHz) / 1 kHz + Operating mode (PoE)

EUT/Model No.: HE-1101 Temp/Humi: 18 / 34  
 -----  
 Test Mode : 1kHz + Operating mode Tested by: KIM T W  
 -----



EUT/Model No.: HE-1101 Temp/Humi: 18 / 34  
 -----  
 Test Mode : 1kHz + Operating mode Tested by: KIM T W  
 -----



Distance : 4.5 m

Ver Data: 869 Hor Data: 868

Freq.(MHz)	Reading(PK)	Reading(AV)	C.F	Result(PK)	Result(AV)	Limit(PK)	Limit(AV)	Margin(PK)	Margin(AV)	Height	Angle	Polarity
MHz	dBuV	dBuV	dB	dBuV/m	dBuV/m	dBuV/m	dBuV/m	dB	dB	cm	deg	Hor/Ver
2155.0	53.7	39.7	0.21	53.86	39.87	76.0	56.0	22.14	16.13	100	157	H
2440.0	56.2	42.0	1.44	57.65	43.47	76.0	56.0	18.35	12.53	100	182	H
3200.0	52.8	38.7	6	58.77	44.66	80.0	60.0	21.23	15.34	100	173	H
1040.0	60.3	47.1	-6.96	53.34	40.13	76.0	56.0	22.66	15.87	100	194	V
1125.0	61.7	48.6	-6.25	55.49	42.39	76.0	56.0	20.51	13.61	100	172	V
2970.0	49.2	35.7	4.08	53.24	39.73	76.0	56.0	22.76	16.27	100	176	V

### 3.2.3 Harmonic Current (AC power input port)

**Definition:**

This part deals with the Limitation of harmonic currents injected into the public supply system.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	: EN 61000-3-2:2014
Test mode	: 1 kHz + Operating mode (Adapter)
Rated power	: 6.709 W
Result	: <b>Complies</b>



**Measurement Data:**

- Uncertainty(HAR) = +/- 2.24 % (with a 95 % confidence level, k=2)

“It has been demonstrated that the HAR generator meets the specified requirements in the standard with at least 95 % confidence.”



**Harmonic Current (AC power input port) / 1 kHz + Operating mode (Adapter)**

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		<b>BSEN61000-3-2:2014 Fluctuating Harmonics</b>	
			
Instrument Details			
Instrument Model	PPA5511		
Serial Number	162-04957		
Firmware Version	2.168		
N4L Calibration Date	18th September 2017		
Instrument Version	Standard		
Test Settings			
Class	Class A		
Mode	Measured		
Equipment Under Test			
Brand	IDIS CO., LTD.		
Model	HE-1101		
Serial	N/A		
Impedance Network ID	N/A		
Test Conditions			
	User Entered	Measured	
Rated Voltage	230	230.674V	
Rated Current	N/A	78.049mA	
Rated Frequency	50	50.000Hz	
Rated Power	N/A	6.709W	
Additional Test Information			
Measured Power Factor	0.373		
Max Current THD	171.53%		
Max THC	72.267mA		
Max Power	6.754W		
Max F.Current	43.664mA		
Average F.Current	42.780mA		
Minimum Current	100A		
Test Duration	2.5 minutes		
Additional Test Details			
Operator	KIM T W		
Lab Name	LTA		
Location	N/A		
Notes			
Signature			
<b>Results</b>	<b>Test - N/A. Rated Power &lt; 75W</b>		

Test not applicable

With the exception of lighting equipment section 7 of the BSEN61000-3-2:2014 standard declares that no Harmonic current limits are specified for equipment with a rated power of

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<b>BSEN61000-3-2:2014 Fluctuating Harmonics</b>							
<b>Instrument Details</b>							
Instrument Model	PPA5511						
Instrument Serial	162-04957						
Instrument Firmware	2.168						
<b>Equipment Under Test</b>							
Brand	IDIS CO., LTD.						
Model	HE-1101						
Serial	N/A						
<b>Extra Test Information</b>							
	Average	Peak		Limit			
THC	71.092mA	72.267mA		N/A			
POHC	19.877mA	20.665mA		251.375mA			
Voltage Crest Factor	1.40521	1.40626		1.40 to 1.42			
Current Crest Factor	10.231	13.685		N/A			
<b>Harmonics Results 1/1</b>							
Harmonic	Status	Avg (A)	Avg L(A)	Avg %ofI	Peak (A)	Peak L(A)	Peak %ofI
1	N/A	0.04278	N/A	N/A	0.04366	N/A	N/A
2	N/A	0.00513	N/A	N/A	0.00575	N/A	N/A
3	N/A	0.02758	N/A	N/A	0.02823	N/A	N/A
4	N/A	0.00503	N/A	N/A	0.0056	N/A	N/A
5	N/A	0.02673	N/A	N/A	0.02764	N/A	N/A
6	N/A	0.00496	N/A	N/A	0.00571	N/A	N/A
7	N/A	0.02545	N/A	N/A	0.02634	N/A	N/A
8	N/A	0.00495	N/A	N/A	0.00543	N/A	N/A
9	N/A	0.02373	N/A	N/A	0.02459	N/A	N/A
10	N/A	0.00494	N/A	N/A	0.00546	N/A	N/A
11	N/A	0.02163	N/A	N/A	0.0225	N/A	N/A
12	N/A	0.0049	N/A	N/A	0.00541	N/A	N/A
13	N/A	0.01941	N/A	N/A	0.02029	N/A	N/A
14	N/A	0.00483	N/A	N/A	0.00545	N/A	N/A
15	N/A	0.01706	N/A	N/A	0.01787	N/A	N/A
16	N/A	0.00483	N/A	N/A	0.00535	N/A	N/A
17	N/A	0.01463	N/A	N/A	0.0156	N/A	N/A
18	N/A	0.00479	N/A	N/A	0.00528	N/A	N/A
19	N/A	0.01229	N/A	N/A	0.013	N/A	N/A
20	N/A	0.00477	N/A	N/A	0.00545	N/A	N/A
21	N/A	0.01013	N/A	N/A	0.01101	N/A	N/A
22	N/A	0.00474	N/A	N/A	0.00541	N/A	N/A
23	N/A	0.00815	N/A	N/A	0.00898	N/A	N/A
24	N/A	0.00478	N/A	N/A	0.00528	N/A	N/A
25	N/A	0.0066	N/A	N/A	0.00727	N/A	N/A
26	N/A	0.00478	N/A	N/A	0.00521	N/A	N/A
27	N/A	0.00549	N/A	N/A	0.00611	N/A	N/A
28	N/A	0.00479	N/A	N/A	0.00532	N/A	N/A
29	N/A	0.00493	N/A	N/A	0.00578	N/A	N/A
30	N/A	0.00478	N/A	N/A	0.00527	N/A	N/A
31	N/A	0.0048	N/A	N/A	0.00528	N/A	N/A
32	N/A	0.0048	N/A	N/A	0.00535	N/A	N/A
33	N/A	0.00489	N/A	N/A	0.00541	N/A	N/A
34	N/A	0.00476	N/A	N/A	0.00536	N/A	N/A
35	N/A	0.00511	N/A	N/A	0.00561	N/A	N/A
36	N/A	0.00479	N/A	N/A	0.00532	N/A	N/A
37	N/A	0.0052	N/A	N/A	0.00572	N/A	N/A
38	N/A	0.00477	N/A	N/A	0.00524	N/A	N/A
39	N/A	0.00525	N/A	N/A	0.00597	N/A	N/A
40	N/A	0.00477	N/A	N/A	0.00541	N/A	N/A

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BSEN61000-3-2:2014 Fluctuating Harmonics				
Instrument Details				
Instrument Model	PPA5511			
Instrument Serial	162-04957			
Instrument Firmware	2.168			
Equipment Under Test				
Brand	IDIS CO., LTD.			
Model	HE-1101			
Serial	N/A			
Source Results 1/1				
Harmonic	Status	Peak (V)	Average (V)	Limit (V)
1	PASS	230.65	230.64	No Limit
2	PASS	0.1312	0.12111	0.46135
3	PASS	0.07261	0.06541	2.0761
4	PASS	0.02871	0.02416	0.46135
5	PASS	0.03126	0.0242	0.9227
6	PASS	0.02813	0.02317	0.46135
7	PASS	0.02891	0.02407	0.69203
8	PASS	0.02751	0.02226	0.46135
9	PASS	0.02789	0.02306	0.46135
10	PASS	0.02656	0.02224	0.46135
11	PASS	0.02793	0.02319	0.23068
12	PASS	0.02765	0.02299	0.23068
13	PASS	0.02847	0.02335	0.23068
14	PASS	0.02597	0.02218	0.23068
15	PASS	0.0317	0.02563	0.23068
16	PASS	0.02719	0.02219	0.23068
17	PASS	0.02742	0.02227	0.23068
18	PASS	0.0296	0.02272	0.23068
19	PASS	0.02738	0.02334	0.23068
20	PASS	0.02766	0.02238	0.23068
21	PASS	0.02743	0.02196	0.23068
22	PASS	0.02746	0.02191	0.23068
23	PASS	0.03026	0.02453	0.23068
24	PASS	0.02718	0.02271	0.23068
25	PASS	0.02674	0.02253	0.23068
26	PASS	0.02891	0.02312	0.23068
27	PASS	0.02836	0.02319	0.23068
28	PASS	0.02624	0.02176	0.23068
29	PASS	0.02674	0.02197	0.23068
30	PASS	0.02687	0.02246	0.23068
31	PASS	0.02869	0.02304	0.23068
32	PASS	0.02815	0.02237	0.23068
33	PASS	0.02851	0.02249	0.23068
34	PASS	0.02773	0.02234	0.23068
35	PASS	0.02893	0.02218	0.23068
36	PASS	0.02759	0.02255	0.23068
37	PASS	0.02864	0.0233	0.23068
38	PASS	0.02978	0.02277	0.23068
39	PASS	0.02958	0.02266	0.23068
40	PASS	0.02695	0.02251	0.23068

### 3.2.4 Voltage Variation and Flicking (AC power input port)

**Definition:**

This section is concerned with the limitation of voltage fluctuations and flicker impressed on the public low-voltage system.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	:	EN 61000-3-3:2013
Test mode	:	1 kHz + Operating mode (Adapter)
Result	:	<b>Complies</b>



**Measurement Data:**

- Uncertainty(FLK) = +/- 9.94 % (with a 95 % confidence level, k=2)

“It has been demonstrated that the FLK generator meets the specified requirements in the standard with at least 95 % confidence.”



## Voltage Variation and Flicking (AC power input port)

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		<b>IEC61000-3-3:2013 Ed.3.0</b>			
		<b>Flickermeter</b>			
Instrument Details					
Instrument Model	PPA5511				
Serial Number	162-04957				
Firmware Version	2.168				
N4L Calibration Date	18th September 2017				
Instrument Version	Standard				
Test Settings					
Class	Voltage				
Mode	Normal (4%)				
Minimum Current	10A				
PST	10.00 minutes				
PLT	1 PSTs				
Equipment Under Test					
Brand	IDIS CO., LTD.				
Model	HE-1101				
Serial	N/A				
Impedance Network ID	N/A				
Test Conditions					
	User Entered		Measured		
Rated Voltage	230		231.149V		
Rated Current	N/A		N/A		
Rated Frequency	50		50.000Hz		
Rated Power	N/A		N/A		
D max	0.0595% (Limit: 4.0%)				
T max	0.0000 s (Limit: 0.5 s)				
DC max	0.0018% (Limit: 3.3%)				
Additional Test Details					
Operator	KIM T W				
Lab Name	LTA				
Location	N/A				
Notes					
Signature					
<b>Results</b>	<b>Phase1: PASS</b>				

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<b>IEC61000-3-3:2013 Ed.3.0 Flickermeter</b>								
<b>Instrument Details</b>								
Instrument Model	PPA5511							
Instrument Serial	162-04957							
Instrument Firmware	2.168							
<b>Equipment Under Test</b>								
Brand	IDIS CO., LTD.							
Model	HE-1101							
Serial	N/A							
<b>Flicker Test Results</b>								
PST no.	Status	DC (%)	Dmax (%)	Tmax (s)	PST	PST Lim	PLT	PLT Lim
1	Phase1: PASS	0.002	0.05954	0	0.082	1.00	N/A	N/A

### 3.3 IMMUNITY

#### 3.3.1 Electrostatic Discharge

**Definition:**

The test assesses the ability of the EUT to operate as intended in the event of an electrostatic discharge.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	:	EN 61000-4-2 :2009
Temperature / Humidity / Pressure	:	22 °C / 41 %RH / 99.9 kPa
Discharge Impedance	:	(330 ±10%)Ω / (150 ±10%) pF
Type of Discharge (air discharge)	:	± 2kV, ± 4 kV, ± 8 kV
Type of Discharge (contact discharge)	:	± 6 kV
Number of discharges at each point	:	10 of each polarity
Discharge Repetition on Rate	:	1 / sec
Test mode	:	1 kHz + Operating mode (Adapter, PoE)
Result	:	<b>Complies</b>

**Measurement Data:**

- Uncertainty(ESD) = +/- 5 % (with a 95 % confidence level, k=2)

“It has been demonstrated that the ESD generator meets the specified requirements in the standard with at least 95 % confidence.”

**Criteria for compliance:**

- There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the discharges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

**1-2. Indirect Discharge**

No.	Position	Kind of Discharge	Results	Remarks
1	HCP	Contact	Complies	EUT Screen disconnected during the test. After the test, EUT was operated normally.
2	VCP	Contact	Complies	EUT Screen disconnected during the test. After the test, EUT was operated normally.

**1-2. Direct Discharge**

No.	Position	Kind of Discharge	Result	Remarks
1	Enclosure #1	Contact	Complies	EUT Screen disconnected during the test. After the test, EUT was operated normally.
2	Enclosure #2	Air	Complies	No reaction recognized
3	DC IN	Air	Complies	EUT Screen disconnected during the test. After the test, EUT was operated normally.
4	LAN	Contact	Complies	EUT Screen disconnected during the test. After the test, EUT was operated normally.
5	USB-B	Contact	Complies	EUT Screen disconnected during the test. After the test, EUT was operated normally.
6	Audio IN	Air	Complies	EUT Screen disconnected during the test. After the test, EUT was operated normally.
7	Audio OUT	Air	Complies	EUT Screen disconnected during the test. After the test, EUT was operated normally.
8	HDMI IN	Contact	Complies	EUT Screen disconnected during the test. After the test, EUT was operated normally.
9	HDMI OUT	Contact	Complies	EUT Screen disconnected during the test. After the test, EUT was operated normally.
10	D-Sub IN	Contact	Complies	EUT Screen disconnected during the test. After the test, EUT was operated normally.
11	D-Sub OUT	Contact	Complies	EUT Screen disconnected during the test. After the test, EUT was operated normally.



### 3.3.2 RF Electromagnetic Field

#### Definition:

The test assesses the ability of the EUT to operate as intended in the presence of a radio frequency electromagnetic field disturbance.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	:	EN 61000-4-3:2006/A2:2010
Frequency range	:	80 MHz to 2 700 MHz
Test level	:	10 V/m (measured unmodulated)
Amplitude Modulation	:	AM, 80 %, 1 kHz Sinusoidal PM, 1 Hz (0.5s ON : 0.5s OFF)
Step size	:	1 % of fundamental
Dwell Time	:	3 s
Test mode	:	1 kHz + Operating mode (Adapter, PoE)
Result	:	<b>Complies</b>

#### Measurement Data:

- Uncertainty = +/- 1.6dB (with a 95 % confidence level, k=2.28)

“It has been demonstrated that the RS generator meets the specified requirements in the standard with at least 95 % confidence.”

MODE : 1 kHz + Operating mode (Adapter)

Port	Test level (V/m)	Result		Remark
		Horizontal	Vertical	
Enclosure	10	Complies	Complies	No reaction recognized

MODE : 1 kHz + Operating mode (PoE)

Port	Test level (V/m)	Result		Remark
		Horizontal	Vertical	
Enclosure	10	Complies	Complies	No reaction recognized

**Criteria for compliance:**

- There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at a field strength of 3 V/m.

- For components of CCTV systems, where the status is monitored by observing the TV picture, then deterioration of the picture is allowed at 10 V/m.

- a) There is no permanent damage or change to the EUT.
- b) At 3 V/m, any deterioration of the picture is so minor that the system could still be used.
- c) There is no observable deterioration of the picture at 1 V/m

### 3.3.3 Electrical fast transients

#### Definition:

The test assesses the ability of the EUT to operate as intended in the event of fast transients presence on one of the input/output ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	:	EN 61000-4-4:2012
Cable length	:	> 3 m
Test level	:	2.0 kV ( AC power input port) 1.0 kV (Signal port)
Polarity	:	Negative/ positive
Repetition frequency	:	100 kHz
Test mode	:	1 kHz + Operating mode (Adapter, PoE)
Result	:	<b>Complies</b>

#### Measurement Data:

- Uncertainty = +/- 10 % (with a 95 % confidence level, k=2)

“It has been demonstrated that the EFT/Burst generator meets the specified requirements in the standard with at least 95 % confidence.”

#### Criteria for compliance:

- There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the discharges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

MODE : 1 kHz + Operating mode (Adapter)

Power Line	Test level	Result	Remarks
L - N	+ 2 kV	Complies	No reaction recognized
	- 2 kV	Complies	No reaction recognized

Signal Line	Test level	Result	Remarks
LAN	+ 1 kV	Complies	No reaction recognized
	- 1 kV	Complies	No reaction recognized

MODE : 1 kHz + Operating mode (PoE)

Signal Line	Test level	Result	Remarks
POE	+ 1 kV	Complies	No reaction recognized
	- 1 kV	Complies	No reaction recognized

### 3.3.4 Surge

**Definition:**

The test assesses the ability of the EUT to operate as intended in the event of surge presence on the AC main power input ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	:	EN 61000-4-5:2014
Test level	:	$\pm 0.5$ kV, $\pm 1$ kV (line to line) $\pm 0.5$ kV, $\pm 1$ kV, $\pm 2$ kV (line to ground), $\pm 0.5$ kV, $\pm 1$ kV (signal line)
Polarity	:	Negative/ positive
Wave shape	:	1.2/ 50 $\mu$ s pulse
Number of surges	:	5 (at each phase)
Test mode	:	1 kHz + Operating mode (Adapter, PoE)
Result	:	<b>Complies</b>

**Measurement Data:**

- Uncertainty = +/- 10 % (with a 95 % confidence level, k=2)

“It has been demonstrated that the Surge generator meets the specified requirements in the standard with at least 95 % confidence.”

**Criteria for compliance:**

- There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the discharges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

## MODE : 1 kHz + Operating mode (Adapter)

Phase	Line	level	Result	Phase	Line	level	Result
0°	Line(L) to line(N)	+1 kV	Complies	90°	Line(L) to line(N)	+1 kV	Complies
		-1 kV	Complies			-1 kV	Complies
	Line(L) to ground(PE)	-	-		Line(L) to ground(PE)	-	-
		-	-			-	-
	Line(N) to ground(PE)	-	-		Line(N) to ground(PE)	-	-
		-	-			-	-
180°	Line(L) to line(N)	+1 kV	Complies	270°	Line(L) to line(N)	+1 kV	Complies
		-1 kV	Complies			-1 kV	Complies
	Line(L) to ground(PE)	-	-		Line(L) to ground(PE)	-	-
		-	-			-	-
	Line(N) to ground(PE)	-	-		Line(N) to ground(PE)	-	-
		-	-			-	-

## MODE : 1 kHz + Operating mode (PoE)

Signal Line	Test level	Result	Remarks
PoE	+0.5, 1 kV	Complies	No reaction recognized
	-0.5, 1 kV	Complies	No reaction recognized

### 3.3.5 Conducted disturbances, induced by radio-frequency fields

#### Definition:

The test assesses the ability of the EUT to operate as intended in the presence of a radio frequency electromagnetic disturbance on the input/output ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	:	EN 61000-4-6:2014
Frequency range	:	0.15MHz – 100 MHz
Test level	:	10 Vrms unmodulated
Amplitude Modulation	:	AM, 80 %, 1 kHz Sinusoidal
Step size	:	1 % of fundamental.
Test mode	:	1 kHz + Operating mode (Adapter, PoE)
Result	:	<b>Complies</b>

#### Measurement Data:

- Uncertainty = +/-1.25 dB (with a 95 % confidence level, k=2)

MODE : 1 kHz + Operating mode (Adapter)

Port	Test level (Vrms)	Result	Remarks
Power	10	Complies	No reaction recognized

Signal Line	Test level (Vrms)	Result	Remarks
LAN	10	Complies	No reaction recognized

MODE : 1 kHz + Operating mode (PoE)

Signal Line	Test level (Vrms)	Result	Remarks
POE	10	Complies	No reaction recognized

**Criteria for compliance:**

- There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at  $U_0 = 130$  dBuV.
- For components of CCTV systems, where the status is monitored by observing the TV picture, then deterioration of the picture is allowed at  $U_0 = 140$  dBuV.
  - a) There is no permanent damage or change to the EUT.
  - b) At  $U_0 = 130$  dBuV, any deterioration of the picture is so minor that the system could still be used.
  - c) There is no observable deterioration of the picture at  $U_0 = 120$  dBuV

### 3.3.6 Mains supply voltage dips, short interruptions

#### Definition:

The test assesses the ability of the EUT to operate as intended in the event of voltage dips and interruptions present on the AC mains power input ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	:	EN 61000-4-11:2004
Ut	:	230 Vac
Test mode	:	1 kHz + Operating mode (Adapter)
Result	:	<b>Complies</b>

#### Measurement Data:

- Uncertainty = +/- 5 % (with a 95 % confidence level, k=2)

“It has been demonstrated that the Voltage dips generator meets the specified requirements in the standard with at least 95 % confidence.”

Test Level %Ut	Voltage droop and interruptions %Ut	Duration of Reduction ( period)	Result	Remarks
80	20	250	Complies	EUT OFF During the test. Automatic repaly without user’s control. After the test, EUT was operated normally.
70	30	25	Complies	No reaction recognized
40	60	10	Complies	No reaction recognized
0	100	250	Complies	EUT OFF During the test. Automatic repaly without user’s control. After the test, EUT was operated normally.

#### Criteria for compliance:

##### - Mains supply voltage variations

There shall be no damage, malfunction or change of status due to the different supply voltage conditions.

##### - Mains supply voltage dips and short interruptions

There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

During the 250 period power loss, in accordance with the standard, a UPS was used to maintain full operation of the unit.



### 3.3.7 Mains supply voltage variations

#### Definition:

The test assesses the ability of the EUT to operate as intended in the event of voltage variations present on the AC mains power input ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	:	EN 50130-4 Clause 7
Supply Voltage maximum	:	$U_{nom} + 10\%$
Supply Voltage minimum	:	$U_{nom} - 15\%$
Ut	:	230 Vac
Test mode	:	1 kHz + Operating mode (Adapter)
Result	:	<b>Complies</b>

#### Measurement Data:

$U_{nom}$  = Nominal mains voltage. Where provision is made to adapt the equipment to suit a number of nominal supply voltages (e.g. by transformer tap changing), the above conditioning severity shall be applied for each nominal voltage, with the equipment suitably adapted. For equipment which is claimed to be suitable for a range of nominal mains voltages (e.g. 220/240 V) without adaptation,  $U_{max} = (\text{Maximum } U_{nom}) + 10\%$ , and  $U_{min} = (\text{Minimum } U_{nom}) - 15\%$ . In any case the range of  $U_{nom}$  must include the European nominal mains voltage of 230 V.

#### 2 Mains supply voltage variations

230 V / 50 Hz

Test LevelCondition		Test Level (V)	Result	Remarks
Unom	+10%	253	Complies	No reaction recognized
Unom	-15%	195.5	Complies	No reaction recognized

**APPENDIX A**

**TEST EQUIPMENT AND ANCILLARIES USED FOR TESTS**

To facilitate inclusion on each page of the test equipment used for related tests, each item of test equipment are identified by the Test Laboratory.

**Conducted emissions**

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	EMI TEST Receiver	ESR	Rohde & Schwarz	101499	2018.07.11	1 year
<input checked="" type="checkbox"/>	Pulse Limiter	ESH3-Z2	Rohde & Schwarz	100710	2018.03.20	1 year
<input type="checkbox"/>	LISN	ESH3-Z6	Rohde & Schwarz	100378	2018.09.07	1 year
<input checked="" type="checkbox"/>	LISN(main)	ENV216	Rohde & Schwarz	100408	2018.09.07	1 year
<input checked="" type="checkbox"/>	LISN(sub)	KNW-407	Kyoritsu	8-1430-1	2018.09.07	1 year
<input checked="" type="checkbox"/>	TEST PROGRAM	e3_Ver: 5.5.201a	AUDIX	-	-	-
<input checked="" type="checkbox"/>	ISN	ISN T800	TESEQ	27109	2018.01.25	1 year
<input type="checkbox"/>	ISN	ENY81-CA6	Rohde & Schwarz	101565	2018.01.25	1 year
<input type="checkbox"/>	CURRENT PROBE	EZ-17	Rohde & Schwarz	100508	2018.01.25	1 year

**Radiated Emission – Below 1 GHz**

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	EMI TEST Receiver	ESCI7	Rohde & Schwarz	100772	2018.09.07	1 year
<input checked="" type="checkbox"/>	Amplifier (25 dB)	8447D	HP	2944A07974	2018.09.07	1 year
<input checked="" type="checkbox"/>	TRILOG Antenna	VULB9160	SCHWARZBECK	9160-3237	2019.05.16	2 year
<input checked="" type="checkbox"/>	TEST PROGRAM	e3_Ver: 6.2009-10-12a	AUDIX	-	-	-

**Radiated Emission – Above 1 GHz**

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	EMI TEST Receiver	ESCI7	Rohde & Schwarz	100772	2018.09.07	1 year
<input checked="" type="checkbox"/>	Amplifier (25 dB)	8449B	HP	3008A00337	2018.03.20	1 year
<input checked="" type="checkbox"/>	HORN ANTENNA	3115	ETS	00055005	2019.05.16	2 year
<input checked="" type="checkbox"/>	TEST PROGRAM	e3_Ver: 6.2009-10-12a	AUDIX	-	-	-

**Harmonic Current / Voltage Variation and Flicking**

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	Precision Power Analyzer	PPA551	Newtons4th Ltd	162-04957	2018.09.18	1 year
<input checked="" type="checkbox"/>	Reference Impedance Network	ES4152	NF Corp.	9074424	2018.09.07	1 year

**Electrostatic Discharge**

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	ESD Slimulator	ESS-2000	NOISEKEN	ESS0625187	2018.04.04	1 year

**RF Electromagnetic Field**

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	Signal Generator	E4432B	Agilent	MY41310632	2018.05.22	1 year
<input checked="" type="checkbox"/>	Power Meter	E4419B	Agilent	GB38410133	2018.06.09	1 year
<input checked="" type="checkbox"/>	RF POWER AMPLIFIER	ITA0300KL-300	INFINITECH	0300KL 1507 001	-	-
<input checked="" type="checkbox"/>	RF POWER AMPLIFIER	ITA2000KL-120	INFINITECH	200KL 1507 001	-	-
<input checked="" type="checkbox"/>	RF POWER AMPLIFIER	ITA4500KL-70	INFINITECH	4500KL 1507 001	-	-
<input checked="" type="checkbox"/>	RF POWER AMPLIFIER	ITA0750KL-300	INFINITECH	0750KL 1507 001	-	-
<input checked="" type="checkbox"/>	Log.-Per.Antenna (80 MHz ~ 3 GHz)	K9128	RAPA	NONE	-	-
<input type="checkbox"/>	Microphone	MP201	BSWA	530147	2017.11.25	1 year
<input type="checkbox"/>	Sound Acoustic Tester	TST-1000	TESTEK	15065-A	2017.11.28	1 year

**Electrical fast transients**

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	Compact Generator	NX5	EMTEST	P1640185038	2018.03.21	1 year
<input checked="" type="checkbox"/>	AC Power Source	Variac NX1-260-16	EMTEST	P1648188071	2018.03.21	1 year
<input checked="" type="checkbox"/>	Capacitive Coupling Clamp	CCI	EMTEST	P1703190739	2018.03.21	1 year

**Surge**

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	Compact Generator	NX5	EMTEST	P1640185038	2018.03.21	1 year
<input checked="" type="checkbox"/>	AC Power Source	Variac NX1-260-16	EMTEST	P1648188071	2018.03.21	1 year
<input checked="" type="checkbox"/>	Capacitive Coupling Clamp	CCI	EMTEST	P1703190739	2018.03.21	1 year
<input checked="" type="checkbox"/>	CDN	CNV508N1	EMTEST	P1623180335	2018.03.21	1 year

**Conducted disturbances, induced by radio-frequency fields**

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	Signal generator	SML03	R&S	103026/0013	2018.03.20	1 year
<input checked="" type="checkbox"/>	POWER METER	NRVD	R&S	101689	2018.03.20	1 year
<input checked="" type="checkbox"/>	RF Power Amplifier	FLL75A	FRANKONIA	1033	-	-
<input type="checkbox"/>	Sound Acoustic Tester	TST-1000	TESTEK	15065-A	2017.11.28	1 year
<input type="checkbox"/>	Microphone	MP201	BSWA	530147	2017.11.25	1 year
<input checked="" type="checkbox"/>	EM INJECTION CLAMP	TSIC-23	F.C.C	529	2018.06.12	1 year
<input type="checkbox"/>	CDN (M1)	TSCDN-M1-16A	F.C.C	07004	2018.09.07	1 year
<input checked="" type="checkbox"/>	CDN (M2)	TSCDN-M2-16A	F.C.C	07008	2018.09.07	1 year
<input checked="" type="checkbox"/>	CDN (M3)	TSCDN-M3-16A	F.C.C	07017	2018.09.07	1 year

**Mains supply voltage dips, short interruptions**

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	Compact Generator	NX5	EMTEST	P1640185038	2018.03.21	1 year
<input checked="" type="checkbox"/>	AC Power Source	Variac NX1-260-16	EMTEST	P1648188071	2018.03.21	1 year

**Mains supply voltage variations**

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	Compact Generator	NX5	EMTEST	P1640185038	2018.03.21	1 year
<input checked="" type="checkbox"/>	AC Power Source	Variac NX1-260-16	EMTEST	P1648188071	2018.03.21	1 year

**APPENDIX B**  
**PERFORMANCE CRITERIA**

## Performance criteria

The variety and the diversity of the apparatus within the scope of this document makes it difficult to define precise criteria for the evaluation of the immunity test results.

If as a result of the application of the tests defined in this standard, the apparatus becomes dangerous or unsafe then the apparatus shall be deemed to have failed the test.

A functional description and a definition of performance by the manufacture and noted in the test report, based on the following criteria:

## Electrostatic discharge

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of discharge is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test (see Clause 6), after the conditioning.

## Radiated electromagnetic fields

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at a field strength of 3 V/m.

For components of CCTV systems, where the status is monitored by observing the TV picture, then deterioration of the picture is allowed at 10 V/m, providing.

(a) there is no permanent damage or change to the EUT

(e.g. no corruption of memory or changes to programmable setting etc.)

(b) at 3 V/m, any deterioration of the picture is so minor that the system could still be used; and

(c) there is no observable deterioration of the picture at 1 V/m.

The EUT shall meet the acceptance criteria for the functional test(see Clause 6), after the conditioning.

## Fast transient burst / slow high energy voltage surge

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of the bursts is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test (see Clause 6), after the conditioning.

## Slow high energy voltage surge

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of the surges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test (see Clause 6), after the conditioning.

### **Conducted RF immunity**

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at  $U_0 = 130 \text{ dB}\mu\text{V}$ .

For components of CCTV systems, where the status is monitored by observing the TV picture, then deterioration of the picture is allowed at  $U_0 = 140 \text{ dB}\mu\text{V}$ , providing

(a) there is no permanent damage or change to the EUT

(e.g. no corruption of memory or changes to programmable settings, etc.)

(b) at  $U_0 = 130 \text{ dB}\mu\text{V}$ , any deterioration of the picture is so minor that the system could still be used, and

(c) there is no observable deterioration of the picture at  $U_0 = 120 \text{ dB}\mu\text{V}$ .

The EUT shall meet the acceptance criteria for the functional test(see Clause 6), after the conditioning.

### **Voltage dip/interruption / Voltage variation**

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test(see Clause 6), after the conditioning.

### **Mains supply voltage variations**

There shall be no damage, malfunction or change of status due to the different supply voltage conditions. The EUT shall meet the acceptance criteria for the functional test(see Clause 6), during the conditioning.



## **APPENDIX C**

### **Measurement Uncertainty**

- 1. Conducted Emission**
- 2. Radiated Emission**

## 1. Conducted Emission

Input Quantity	Probability Distribution	Probability Distribution (dB)		Standard
		9 kHz – 30 MHz		
Cable loss(RG400)	Standard Deviation(SD)	± 0.061		10 <sup>th</sup> measurement
Receiver corrections; -Sine wave voltage -Pulse amplitude response -Pulse repetition rate response	Rectangular ( $\sqrt{3}$ ) Rectangular ( $\sqrt{3}$ ) Rectangular ( $\sqrt{3}$ )	± 0.17 ± 0.02 ± 0.58		Cal. Report Cal. Report Cal. Report
LISN corrections (ENV216) ; -Voltage division factor	Normal (k = 2)	± 0.09		Cal. Report
Mismatch ; - Receiver VRC* : $\Gamma_i = 0.09$ -LISN VRC : $\Gamma_g = 0.14(150\text{kHz})$ = $0.05(30\text{MHz})$ - Uncertainty: $20\log(1 \pm \Gamma_i \Gamma_g)$	U-type( $\sqrt{2}$ )	± 0.89		Cal. Report
System Repeatability	Standard Deviation(SD)	± 0.28		10 <sup>th</sup> measurement
Combined measurement uncertainty Uc(y)	Normal	+ 0.73 - 0.73		
Expanded measurement uncertainty (95%,Confidence level,k = 2)dB	Normal(k = 2)	+ 1.46 - 1.46		

## 2. Below 1 GHz Radiated Emission

Input Quantity	Probability Distribution	Probability Distribution (dB)		Standard
		Trilog		
		3m	10m	
Antenna Factor (VULB 9160)	Normal (k = 2)	30 MHz – 1 GHz ± 2.00	30 MHz – 1 GHz ± 2.00	ANT Cal. uncertainty
Cable loss (HFB-5010/HFC12D)	Standard Deviation(SD)	± 0.14	± 0.14	10 <sup>th</sup> measurement
Receiver corrections; -Sine Wave Voltage -Pulse amplitude response -Pulse repetition rate response	Normal (k = 2) Normal (k = 2) Rectangular( $\sqrt{3}$ )	± 0.17 ± 0.58 ± 1.50	± 0.17 ± 0.58 ± 1.50	Cal. Report Cal. Report CISPR16-4-2
Antenna Directivity	Rectangular( $\sqrt{3}$ )	± 1.00	± 1.00	CISPR16-4-2
AF Height Dependence	Rectangular( $\sqrt{3}$ )	± 0.10	± 0.10	CISPR16-4-2
Phase Center Location	Rectangular( $\sqrt{3}$ )	± 0.20	± 0.20	CISPR16-4-2
Separation Distance	Rectangular( $\sqrt{3}$ )	± 0.30	± 0.30	CISPR16-4-2
Uncertainty of Site	Triangular( $\sqrt{6}$ )	± 2.97	± 2.97	NSA
Mismatch ; - Receiver VRC* : $\Gamma_i = 0.09$ -ANT. VRC : $\Gamma_g = 0.09$ - Uncertainty: $20\log(1 \pm \Gamma_i \Gamma_g)$	U-type ( $\sqrt{2}$ )	± 0.54	± 0.54	CISPR16-4-2
Pre-amp.	Normal (k = 2)	± 0.14	± 0.14	Cal. Report
System Repeatability	Standard Deviation(SD)	± 0.60	± 0.60	10 <sup>th</sup> measurement
Combined measurement uncertainty Uc(y)	Normal	+ 1.97 - 1.97	+ 1.97 - 1.97	
Expanded measurement uncertainty (95%,Confidence level,k=2)dB	Normal(k = 2)	30 MHz – 1 GHz + 3.94 - 3.94	30 MHz – 1 GHz + 3.94 - 3.94	

Note:VRC(Voltage Reflection Coefficient)

## 3. Above 1 GHz Radiated Emission

Input Quantity	Probability Distribution	Probability Distribution (dB)	Standard
		HORN	
Antenna Factor (ETS 3115)	Normal (k=2) (normal)	1 GHz - 6 GHz ± 1.00	ANT Cal. uncertainty
Cable loss (SUHNER MULTIFLEX microwave cables)	Standard Deviation(SD)	± 0.32	10 <sup>th</sup> measurement
Receiver corrections; -Sine Wave Voltage -Pulse amplitude response -Pulse repetition rate response	Normal (k = 2) Normal (k = 2) Rectangular(√ 3)	± 0.17 ± 0.58 ± 1.50	Cal. Report Cal. Report CISPR16-4-2
Antenna Directivity	Rectangular(√ 3)	± 1.00	CISPR16-4-2
AF Height Dependence	Rectangular(√ 3)	± 0.10	CISPR16-4-2
Phase Center Location	Rectangular(√ 3)	± 0.20	CISPR16-4-2
Separation Distance	Rectangular(√ 3)	± 0.30	CISPR16-4-2
Uncertainty of Site	Standard Deviation(SD)	± 0.13	SVSWR 10 <sup>th</sup> measurement
Mismatch ; - Receiver VRC* : $\Gamma_i = 0.09$ -ANT. VRC : $\Gamma_g = 0.09$ - Uncertainty: $20\log(1 \pm \Gamma_i \Gamma_g)$	U-type (√ 2)	± 0.54	CISPR16-4-2
Pre-amp.	Normal (k = 2)	± 0.60	Cal. Report
System Repeatability	Standard Deviation(SD)	± 0.34	10 <sup>th</sup> measurement
Combined measurement uncertainty $U_c(y)$	Normal	+ 1.73 - 1.73	
Expanded measurement uncertainty (95%,Confidence level,k=2)dB	Normal(k = 2)	1 GHz - 6 GHz + 3.46 - 3.46	

Note:VRC(Voltage Reflection Coefficient)

**APPENDIX D**

**PHOTOGRAPHS**

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**Conducted emission (Maximum emission configuration) / 1 kHz + Operating mode (Adapter)**

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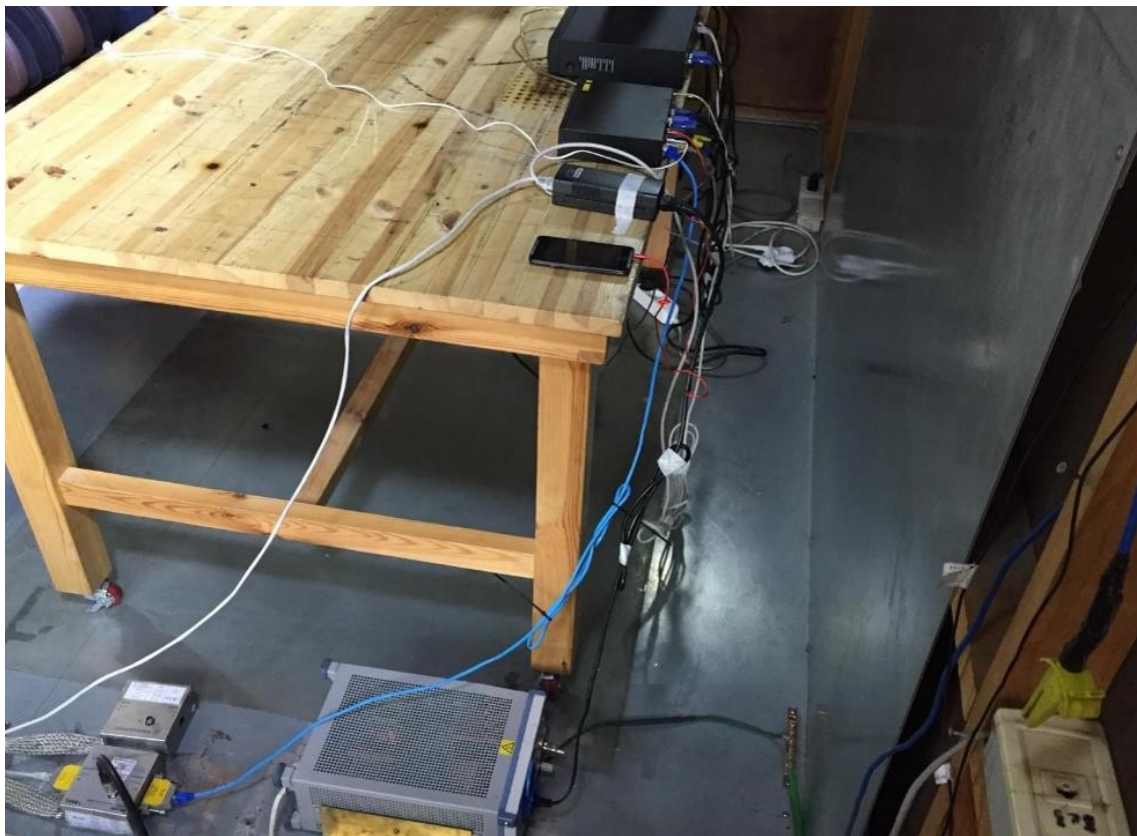


**Conducted emission (Maximum emission configuration) / TEL \_ 1 kHz + Operating mode (Adapter)**





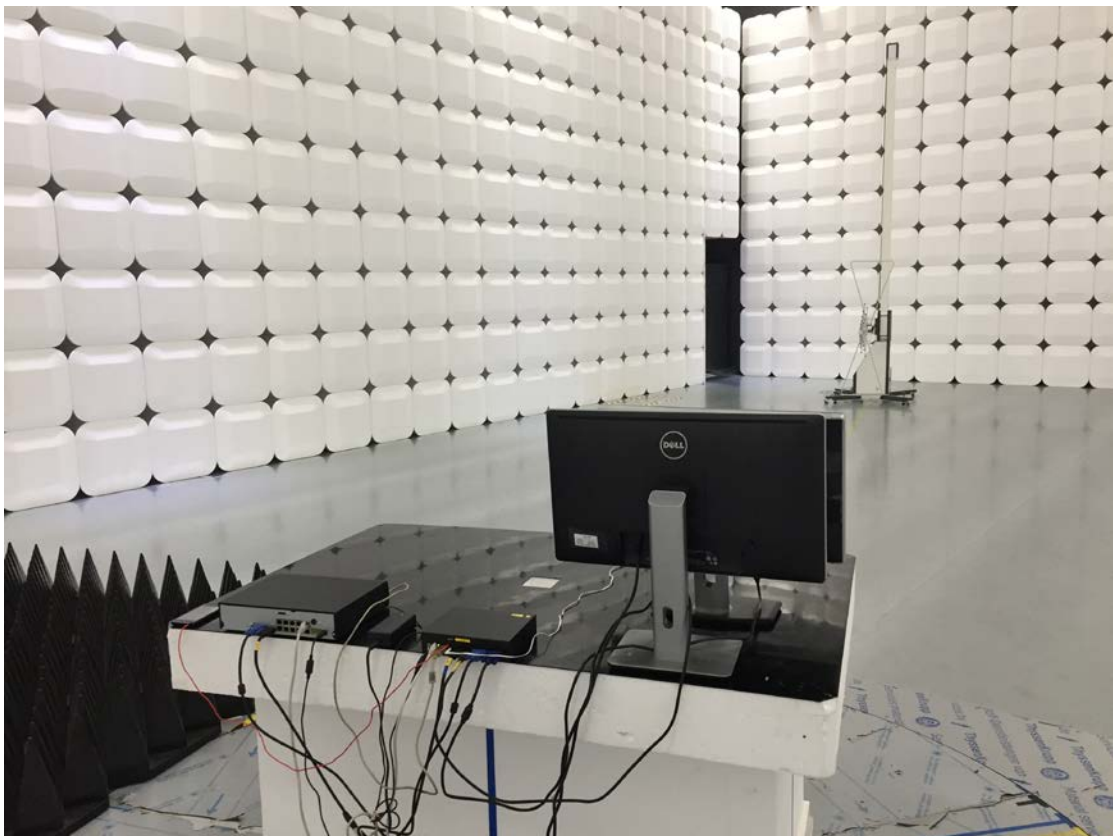
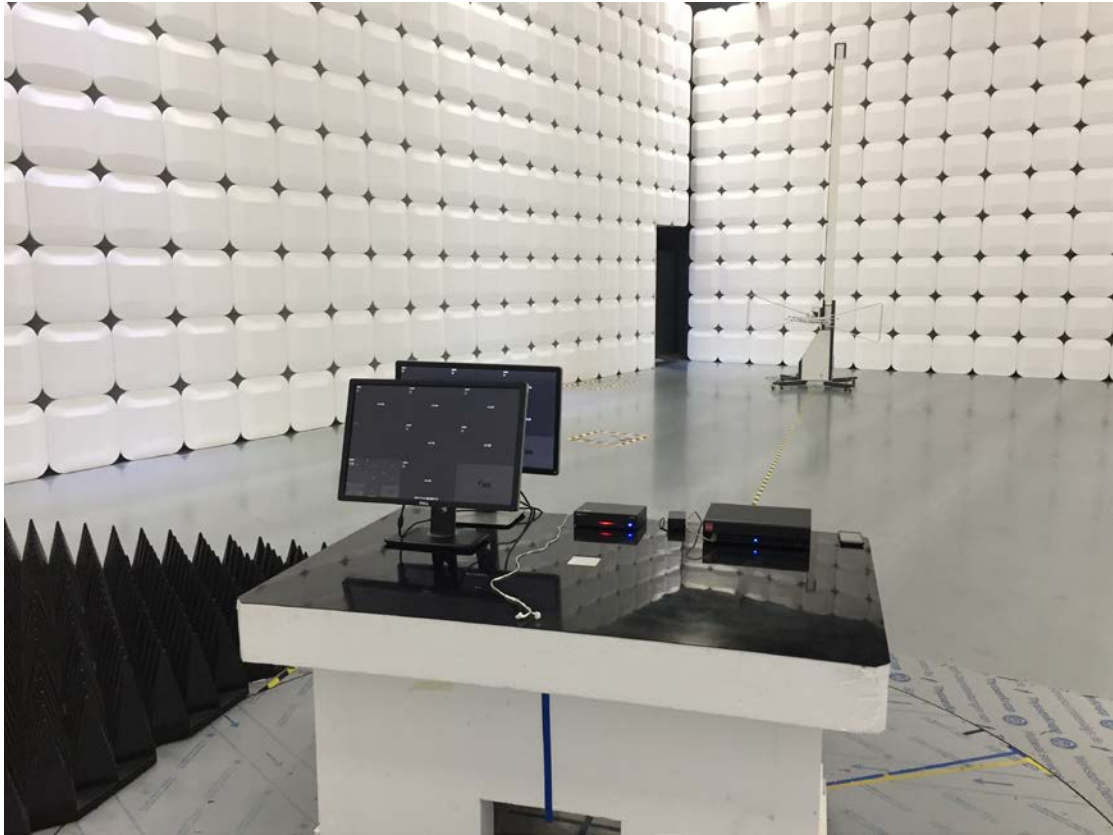
**Conducted emission (Maximum emission configuration) / TEL \_ 1 kHz + Operating mode (PoE)**



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**Radiated emission (Maximum emission configuration)-Below 1 GHz /  
1 kHz + Operating mode (Adapter)**

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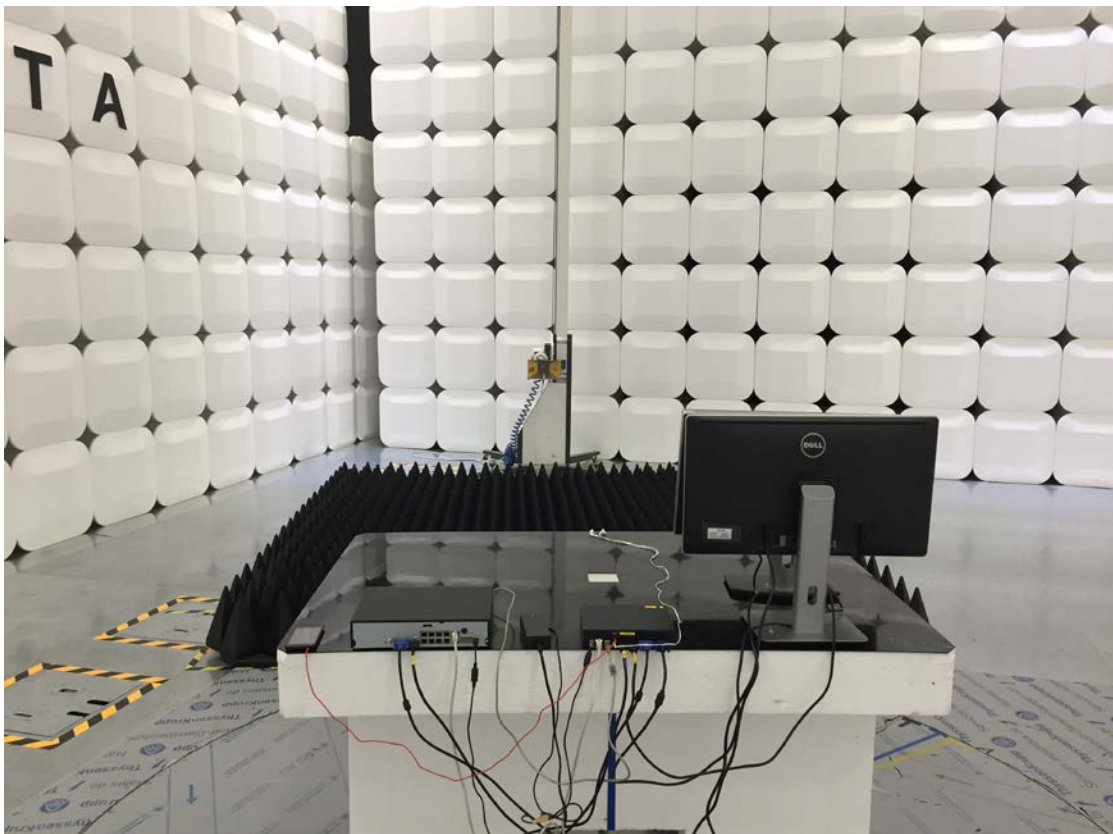
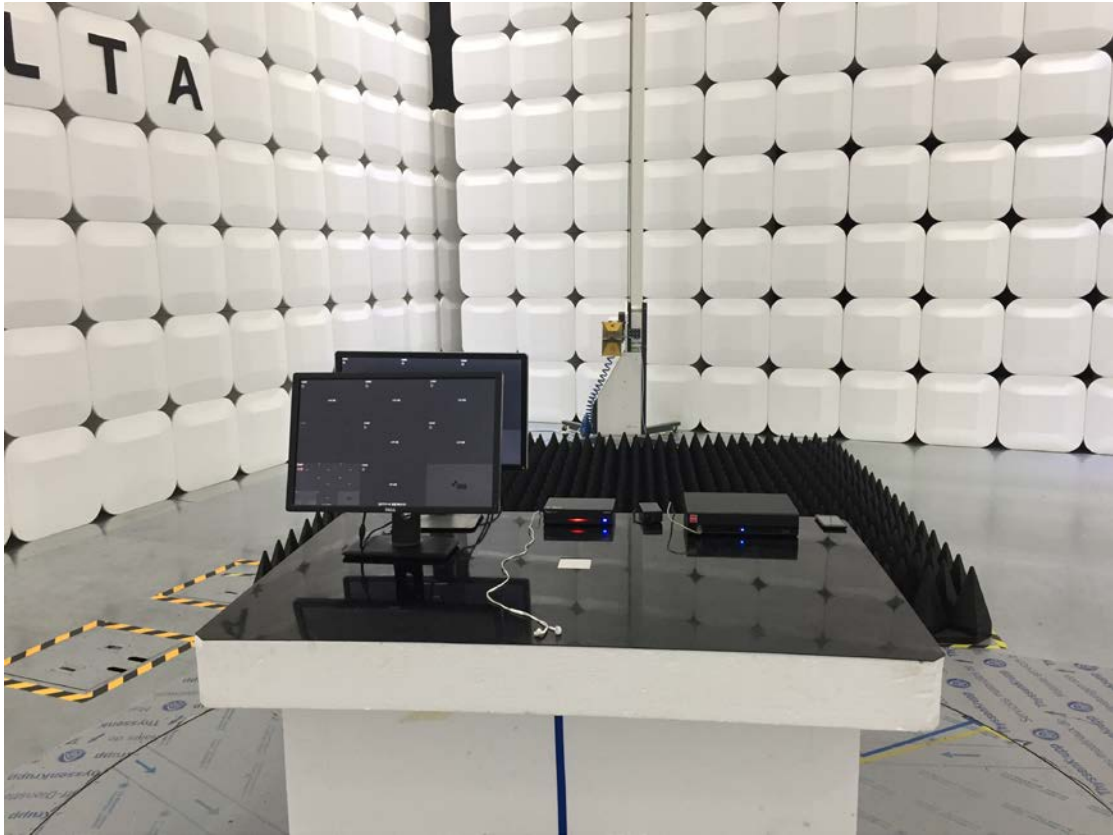




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**Radiated emission (Maximum emission configuration)-Above 1 GHz /  
1 kHz + Operating mode (Adapter)**

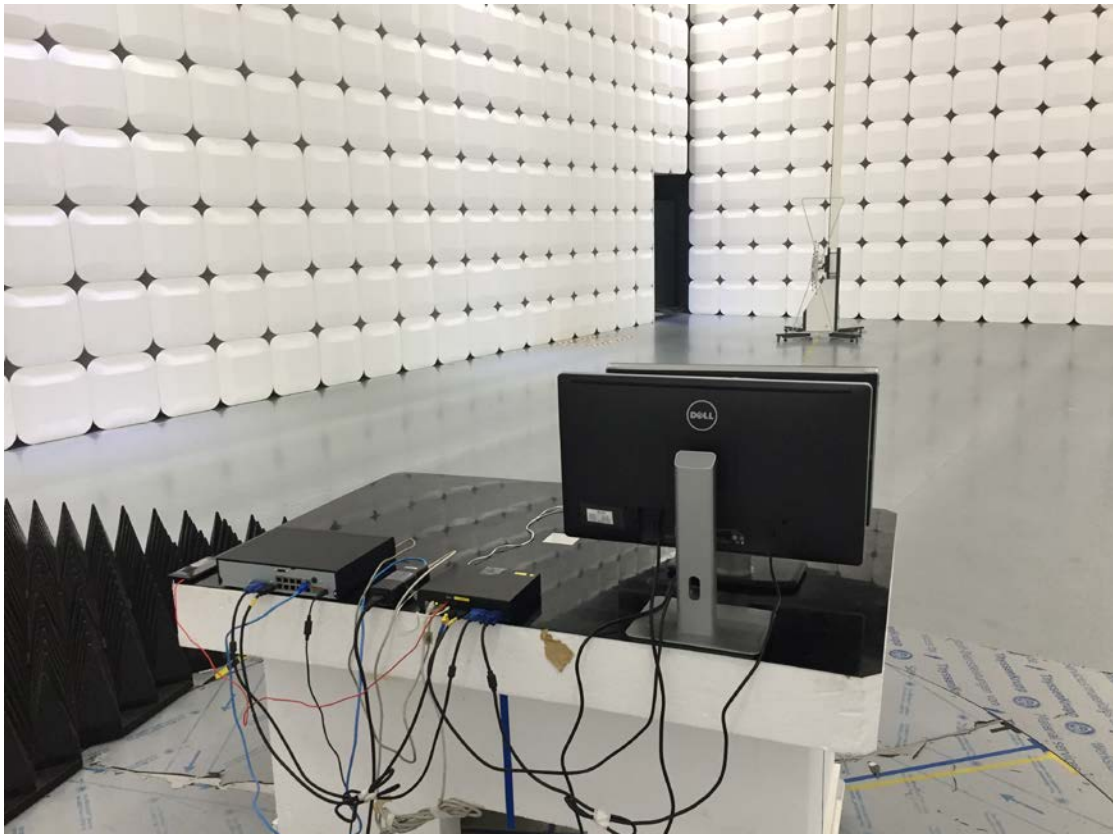
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**Radiated emission (Maximum emission configuration)-Below 1 GHz /  
1 kHz + Operating mode (PoE)**

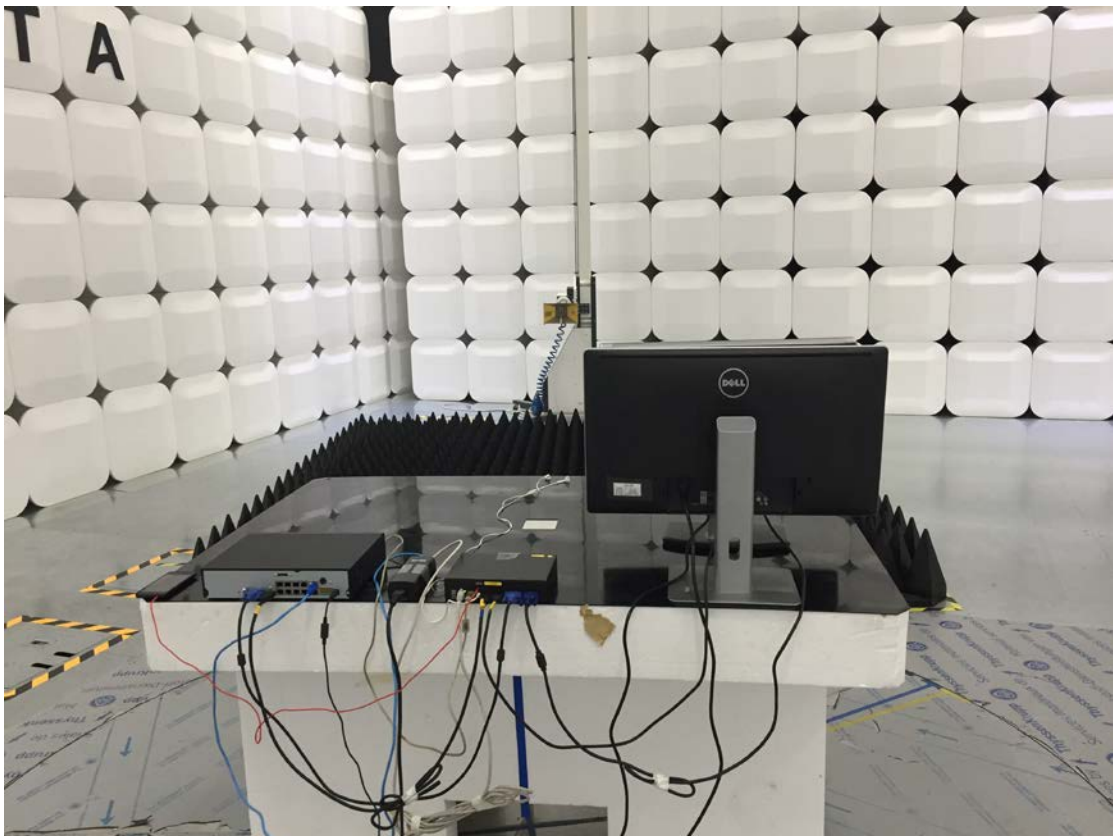
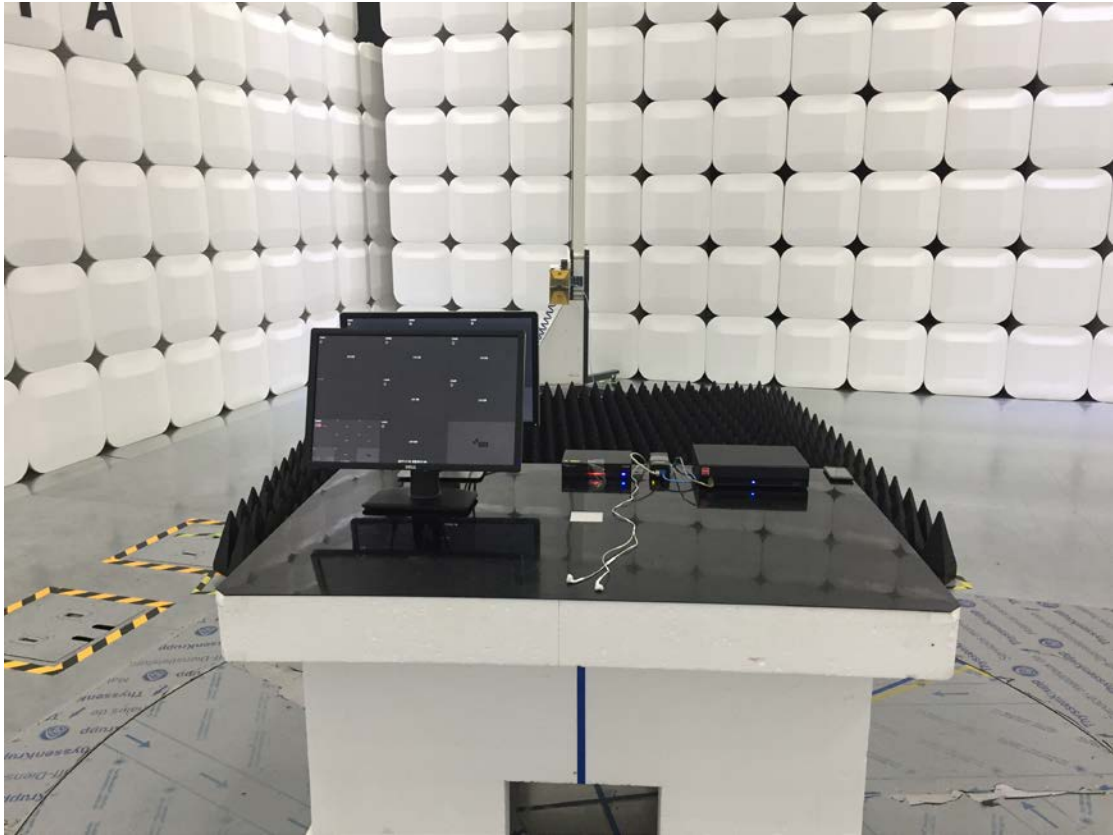
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**Radiated emission (Maximum emission configuration)-Above 1 GHz /  
1 kHz + Operating mode (PoE)**

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**Harmonic Current / 1 kHz + Operating mode (Adapter)**

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**Electrostatic discharge / 1 kHz + Operating mode (Adapter)**

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**Electrostatic discharge / 1 kHz + Operating mode (PoE)**

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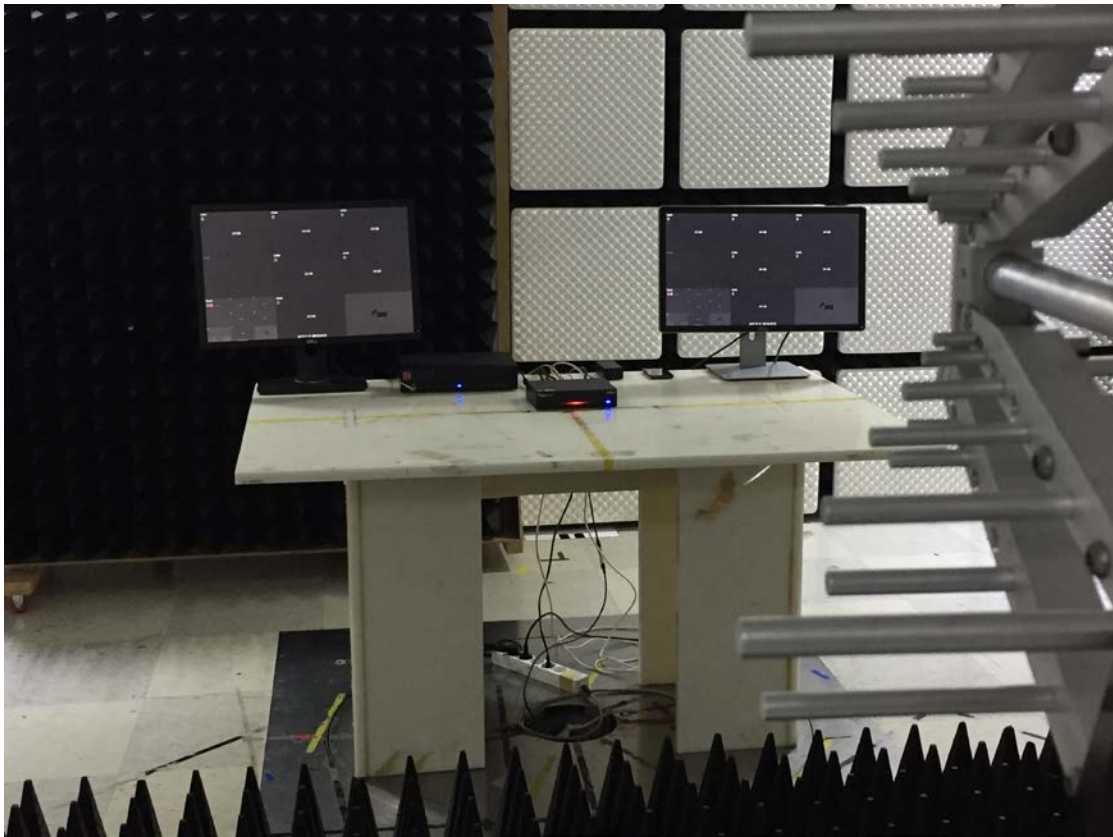
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**RF Electromagnetic Field / 1 kHz + Operating mode (Adapter)**

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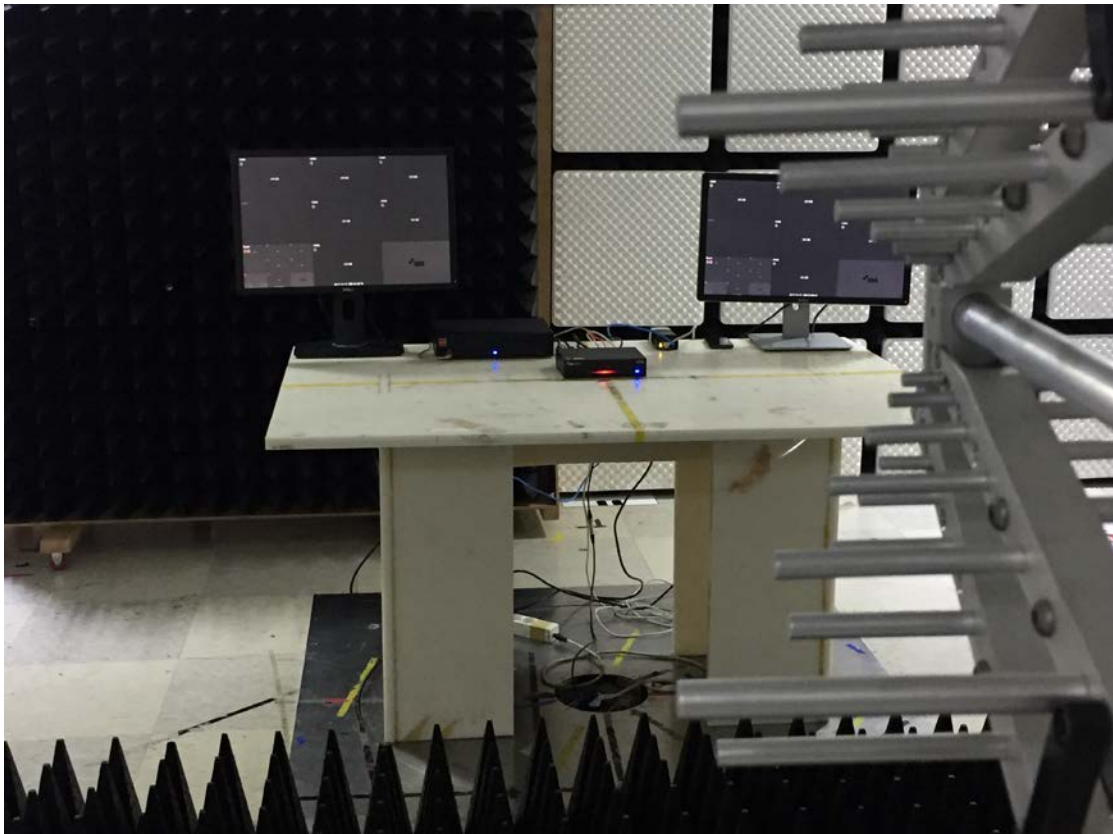
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**RF Electromagnetic Field / 1 kHz + Operating mode (PoE)**

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**Electrical fast transients / 1 kHz + Operating mode (Adapter)**

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**Electrical fast transients / 1 kHz + Operating mode (PoE)**

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**Surge / 1 kHz + Operating mode (Adapter)**

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**Surge / 1 kHz + Operating mode (PoE)**

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**Conducted Disturbances, Induced by Radio-Frequency Fields / 1 kHz + Operating mode  
(Adapter)**

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**Conducted Disturbances, Induced by Radio-Frequency Fields / 1 kHz + Operating mode (PoE)**

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**Main supply voltage dips, short interruptions / 1 kHz + Operating mode (Adapter)**

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**EUT**

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